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# A Survey of the Preparation, Purity, and Availability of Silanes

**A Subcontract Report** 

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#### PREFACE

This report was prepared by James H. Lorenz under Consultant Agreement No. CL-3-00321-01, Prime Contract No. EG-77-C-01-4042, for the Solar Energy Research Institute. The objective of this work was to provide researchers in the field of amorphous silicon with up-to-date information on silane and disilane.

Users of silanes in general should find this report of interest for its surveys of the preparation and purification procedures of silanes and for the summaries of the industrial aspects of processes used commercially in the United States and Japan. Comments on the purity of available silanes and its impact on photovoltaic device performance are presented. Information supplied by silane producers as well as the purity analysis data supplied by Dr. Reed Corderman of Brookhaven National Laboratory is gratefully acknowledged. The constructive reviews by Dr. Corderman and Dr. Ralph Lutwack of the Jet Propulsion Laboratory were very helpful.

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### SUMMARY

This report presents data on the current silane market. Published and public information on 22 preparative methods for monosilane and higher silanes are reviewed. Twenty-four referenced purification methods are presented and discussed. Sources for the contaminants in silanes are identified. The effects of impurities in silane on solar cell performance are included, and data from current suppliers of silane are tabulated, including processes used, prices, and available grades. Typical and actual analyses of commercial silanes are also given.

The silane process developed by Union Carbide Corporation under the DOE/JPL Flat-Plate Solar Array Project is summarized, including the purification steps. A section on the status of silanes in Japan is also included.

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#### SECTION 1.0

### INTRODUCTION

Monosilane was first prepared in the laboratory in the mid-1880s and further defined along with higher order species in the 1920s. Commercial activity began in the 1960s. The merchant market for silane is still measured in grams, because its only use has been for the deposition of epitaxial layers of silicon or silicon nitride in semiconductor production. In 1980, the total market for silane was estimated to be on the order of 40,000,000 grams (40 tons). Several firms, such as Komatsu Electronic Metals Company in Japan, began making silane and depositing silicon from it to obtain a very pure poly-These have been the only commercial uses for silane. However, as silicon. large markets develop for amorphous silicon arrays in the photovoltaics field and as several companies continue to develop the use of silane for polysilicon production in the United States, improved silane manufacturing processes should result.

This report presents an overview of the current situation concerning silanes in the United States and in Japan. Areas discussed include

- Market summaries
- Published methods for preparing silane
- Discussion of possible impurities
- Impurity levels of commercial silane and disilane
- Published or recommended purification techniques
- Commercial availability of silane and disilane.

The new silane process described in the Jet Propulsion Laboratories/Department of Energy Flat Plate Solar Array Project reports is also reviewed.

For information about the preparation and purification of silanes, a Chemical Abstracts review was conducted from 1967 forward. For the availability section, a questionnaire was sent to producers and/or sellers in the United States and in Japan. Telephone calls and interviews were also used. For the JPL/DOE projects, quarterly and final reports were used.



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#### SECTION 2.0

### SILANE AND DISILANE IN THE UNITED STATES

#### 2.1 MARKET SUMMARY

The commercial market for silane began in the 1960s with the development of the semiconductor industry. These uses for epitaxial silicon, silicon oxide, or silicon nitride deposits have grown rapidly over the years. Silane was originally sold in small cylinders and priced by the gram. This practice continues today, even though the volume is now in the many thousands of grams.

As of 1982, the semiconductor business was still the only volume market for silane in the United States. Thus, silane quality and packaging have been based on those needs. Cylinders from lecture-bottle sizes up to 16,000 grams are generally available. Several companies indicate that they will offer tube trailer quotes on request. The prices of silane are volume-sensitive, ranging from \$0.16 to \$2.50 per gram.

All of the companies surveyed offered the standard epitaxial deposition resistivity as a measure of purity. None offered an analysis for boron or donors. Direct analysis techniques for determining the boron, arsenic, and phosphorus in silane apparently have not yet been developed. The Semiconductor Equipment and Materials Institute (SEMI) specification analyses are offered for a fee.

Silane for semiconductor uses is sold 100% or diluted with inert gas. Volumes are given as 100% equivalents. In 1980, an estimated 35,000 kg (35 metric tons) was sold in the United States. By 1982, silane use had grown to 40,000 kg. Continued growth of the semiconductor markets is expected. There is no merchant market for solar cells, as yet. The U.S. production capacity for silane is estimated to be over 55,000 kg, plus the silane that will be marketed from the new Union Carbide polysilicon plant of 120 tons.

Disilane is currently offered by four companies: Airco (distributor for Chronar), Matheson, Scientific Gas, and Synthatron. This represents a merchant market for research and development quantities only in 25-, 50-, or 100-gram cylinders. The price ranges from \$55.00 to \$120.00 per gram.

### 2.2 PREPARATION METHODS FOR SILANE

A literature search yielded data on some 22 methods for preparing silane, most of them found in the literature of the last 20 years. Most of the 22 processes reviewed are research or laboratory methods. Four methods are the ones most commonly used on a commercial scale:

- 1. Lithium hydride with silicon tetrachloride [5]
- 2. Lithium hydride with trichlorosilane [5]
- 3. Magnesium silicide with mineral acids [16]

4. Catalytic redistribution of chlorosilanes [17].

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All of the methods reported here are summarized and referenced.

1. Kuratomi and Yatsurugi [1] claim the following reaction:

 $2H_2 + Si(20\%) + Al(80\%) = SiH_4 + Al$ .

The patent states that 30 liters per minute of  $H_2$  were passed through 600 grams of molten silicon-aluminum (650°) giving 35 grams per hour of silane. The yield is listed at 0.1%. I have not calculated the equilibrium involved, but the JANAF tables [43] present data for the free energy of formation of silane. Experts advise that an equilibrium mixture of hydrogen, silicon, and silane at any temperature could contain only a few ppm of silane. The 0.1% yield is some 2000 times the calculated equilibrium. This small yield could have been due to impurities in the silicon.

2. Jackson, Marsh, and Muetterties [2] report the reaction:

 $2A1 + A1C1_3 + 3H_2 = 3A1H_2C1$  $2A1H_2C1 + SiO_2 = SiH_4 + 2A1OC1$ .

The first reaction to form aluminum haloalane was carried out at 200<sup>o</sup>C and 900 atm. The second was done at "moderate conditions". This does not appear to be a reaction to scale-up.

3. Amberger and Boeters [3] claim the following:

 $3SiO_2 + 4A1 + 12H_2 = 2A1_2O_3 + 3SiH_4$ .

This was done at high temperatures, and the probability of getting silicon metal is great.

- 4. Tachiki and Yamashita [4] claim the use of hydrogen sulfide or sulfides of copper, silicon, or nickel as catalysts for the reaction of hydrogen with powdered silicon at  $35^{\circ}$ C and 50 atm. They further claim that by controlling the ratios of H<sub>2</sub> to silicon, a high yield of any desired silane from SiH<sub>4</sub> to Si<sub>5</sub>H<sub>12</sub> can be prepared. This would have to be reviewed very carefully. Thermodynamic data predicts a yield of 10 ppb of silane.
- 5. One of the more popular methods uses lithium hydride. Sundermeyer [5] was granted several patents in the early 1960s for the semicontinuous preparation of silane. Electrolysis of a LiCl/KCl mixture at  $400^{\circ}$ C for 4 minutes at 4 V, 32 A yielded lithium metal at 75% efficiency. Lithium was reacted with hydrogen to give lithium hydride. LiH was reacted with SiCl<sub>4</sub> to give SiH<sub>4</sub> at 73%. The yield was 99.5% when excess SiCl<sub>4</sub> was used. Purity was in ppm. Later, Sundermeyer and Litz [6] reported a continuous operation.

Litz and Ring [7] in 1964 patented a process for the electrolysis of a molten lithium chloride/sodium chloride eutectic to produce lithium metal at the cathode and silicon tetrachloride at the silicon anode.



The lithium metal is converted to the hydride by contact with gaseous hydrogen. Lithium hydride is then reacted with the silicon chloride to form silane. One could start with LiH, if this were available. Also, trichloro or dichlorosilane could be the silicon source.

Pavlov et al. [8] prepared silane by bubbling a  $SiCl_4-H_2$  mixture through a melt of LiH in a eutectic mixture of LiCl/KCl. The silane yield was 95% with some disilane and HCl and less than 0.01% of boron, gallium, phosphorus, and antimony.

Franklin, Francis, and Tarancon [9] have a 1976 patent on preparing silane in a single chamber from the above reactions. They merely state that the silicon made from this silane is sufficiently pure for electronic-grade uses.

A 1981 patent to Komatsu [10] describes a nickel system for carrying out this reaction. Although this process is one of the better ones, the silane produced most likely needs some clean-up before use. These reactions are used commercially.

- 6. In 1968, Vit et al. [11] patented the use of sodium hydride or sodium aluminum hydride with silicon tetrachloride to make silane in a boiling tetrahydrofurane system.
- 7. Weiss and Fisher [12] describe the reaction of  $\rm{SiO}_2$  with  $\rm{LiAlH}_4$  at  $200^{\rm o}\rm{C}$ , claiming that ether is the only recognized impurity. This would certainly have to be reviewed by today's standards. Bellama and MacDiarmid [13] list the same reaction, but at  $170^{\rm o}$ . They obtained a 7% yield.
- 8. Finholt et al. [14] describe a simple laboratory method: add  $SiCl_4$  to a mixture of  $LiAlH_4$  in diethyl ether at liquid nitrogen temperatures, then let it warm up to  $0^{\circ}C$ . This technique gives silane with a 99% yield. Jernejcic [15] and Norman et al. [16] also report this reaction.
- 9. Roy [17] prepared silane by the reaction of SiCl<sub>4</sub> with NaBH<sub>4</sub> in a diglyme (a polyether) at ambient temperature. No purity is listed.
- 10. Hance and Wagner [18] reacted triethoxysilane with sodium to obtain silane.
- 11. Kuratomi and Kawakita [20] placed powdered silicon and nickel nitrate in a high-pressure reactor and then treated this with hydrogen to form free nickel. Further addition of hydrogen produced 85% monosilane.
- 12. Lorenz and Whaley [21,22] prepared siloxene from calcium silicide and acid and reacted this with ammonia to obtain silane. A yield of 37% monosilane was obtained with less than 0.1% higher silanes.
- 13. Kuratomi and Yatsurugi [23] reacted SiCl<sub>4</sub> and hydrogen in a molten alloy of 50/50 potassium and sodium to get silane. The product gave a deposited silicon of 50 ohm-cm.

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- 14. Kuratomi [24] states that SiCl<sub>4</sub> with hydrogen at 200<sup>o</sup>-550<sup>o</sup>C in the presence of titanium sponge or titanium hydride gives 37% trichlorosilane, 21% dichlorosilane, 13% monochlorosilane, and 8% silane.
- 15. Tachiki et al. [25] sintered magnesium, silicon, and zinc in a reducing atmosphere, powdered the sinter and added sulphuric acid to get 99.5% pure silane in a 90% yield.
- 16. Stock, in his book published in 1933 [26], described the preparation of magnesium silicide reacted with HCl to yield silanes. He states that 25% of the silicon was converted to silanes: 40%  $Si_{4}$ , 30%  $Si_{2}H_{6}$ , 15%  $Si_{3}H_{8}$  and some higher silanes. Feher [27] adds that having 20% phosphoric acid present aids the reaction toward monosilane. Johnson [28] reports that HBr works quite well also.

Kuratomi and Yatsurugi [29] found that  $Mg_2Si$  with  $NH_4SCN$  dissolved in liquid ammonia gave only a trace of higher silanes. Ebsworth [41] found the magnesium silicide with acid reaction gave a 50% yield of silane when run in hydrazine at  $50^{\circ}C$ . Yusa, Yatsurugi, and Takaishi [33] report that in the current industrial process, silane is generated by reacting magnesium silicide with ammonium chloride in liquid ammonia solution at  $0^{\circ}C$ . These reactions are well documented and are quite straightforward for silane production. At least one of these reactions is used commercially. For higher silanes, economics and purity would have to be studied carefully.

- 17. Bakay [30], in his 1976 patent, described this process: silane is obtained by introducing SiHCl<sub>3</sub> into an ion exchange resin consisting of tertiary and quaternary ammonium groups at 20<sup>o</sup> to 200<sup>o</sup>C. Litteral [31] in 1978 found this reaction could also be done in two steps: trichlorosilane is passed over the resin to make dichlorosilane, and a second pass through the resin gives silane. This process has been used by Union Carbide since 1970 to make dichlorosilane and is discussed in the section on the JPL/DOE process.
- 18. Calcote [32] in his work on low-cost silicon under the JPL/DOE solar array project reported the preparation of high-purity silane in a nonequilibrium jet plasma with sodium and SiCl<sub>4</sub> feed. This gave a very low yield.
- 19. Kutznetsov [34] states that NaH with trialkyl aluminum compounds reduces tetraethoxysilane to silane, with the yield depending on the order of additions--and complicated by side reactions.
- 20. Isano et al. [35] noted that silane can be prepared by decomposing triethoxysilane in the presence of sodium methoxy dissolved in tetraethoxysilane.
- 21. Kuratomi and Kawakita [36] reacted KOH, KH, and SiCl<sub>4</sub> at 370<sup>o</sup>C for silane.

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22. LeFrancois [37,44], in his 1982 patent, presents the preparation of silane by the reaction of a silicon halide, such as silicon tetra-fluoride, with alkali metal hydrides, such as sodium hydride, in a liquid that includes a diaryl ether such as diphenyl ether. At elevated temperatures, such as  $250^{\circ}-260^{\circ}C$ , complete conversion of the silicon tetrahalide to silane was observed, even with contact times under 2 seconds.

This patent, assigned to Allied Corporation, claims the use of silicon chlorides, bromides, or iodides alone or in mixtures with sodium, lithium, or potassium hydrides. Silicon tetrafluoride is preferred, because it is an available by-product in the manufacture of phosphoric acid. Vigorous stirring is required--5,000 to 10,000 rpm. One example cited is NaH in mineral oil slurried in diphenyl ether/ biphenyl. With stirring, equimolar parts of nitrogen and SiF<sub>4</sub> are flowed in at  $255^{\circ}$ C. The effluent gas contains 40% N<sub>2</sub>, 2% SiF<sub>4</sub>, and 56% SiH<sub>4</sub>. Other peaks on the gas chromatograph eluting after silane could be higher silanes. Solid products were equal parts of NaF and Na<sub>2</sub>SiF<sub>6</sub>. No purities were given, but the common impurities found in other methods would probably be present in the silane.

### 2.3 PREPARATION METHODS FOR HIGHER SILANES

There are very few publications on the higher silanes. The most definitive work was done and reported by Stock in 1933 [26]. Dropping magnesium silicide, prepared by reducing silica with metallic magnesium at high temperatures, into aqueous hydrochloric acid solution, formed silanes. The evolving gases had this approximate composition: 40% silane, 30% disilane, 15% trisilane, 10% tetrasilane, and 7% higher silanes.

Johnson and Isenberg [38] studied the preparation of magnesium silicide and its reaction in ammonia and ammonium bromide at low temperatures. They concluded that the yield of disilane was determined by the temperature of the reaction, the nature of the solvents, and the composition of silicides used. If they prepared their magnesium silicide at temperatures of  $500^{\circ}-900^{\circ}C$ , where they state that only the MgSi species can survive, mostly monosilane was obtained. If the silicide was prepared at  $400^{\circ}-500^{\circ}C$ , higher magnesium silicides appeared, such as  $Mg_2Si_2$ . This silicide species favors the formation of disilane. Also, the disilane yield is increased if the silicide is reacted in the ammonia/ammonium bromide solution at  $50^{\circ}C$  instead of at  $-35^{\circ}C$ . In these cases, the disilane in the product was increased from a few percent to 50%-60%. Using traps at various temperatures effects a separation of the silanes.

Finholt et al. [14] in 1947 under a Naval esearch project, defined the lithium aluminum hydride method for higher silanes. When silicon halides are used with  $\text{LiAlH}_4$  in an ether solution at liquid nitrogen temperature, and warmed to room temperature, an almost complete reaction occurs. When silicon tetrachloride is used, a 99% yield of silane is obtained. Lithium hydride could also be used, but the reaction is slower. When hexachlorodisilane is used, an 87% yield of disilane can be obtained. If octochlorotrisilane is used, trisilane resulted. The higher order chlorosilanes are a by-product in



the manufacture of silicones. Because of no market, they are not normally isolated. They can easily be cracked back into useful silicone monomers.

In their 1961 patent, Tachiki and Yamashita [4] claim the use of  $H_2S$  or sulfides of Ni, Cu, or Si as catalysts for the reaction of hydrogen with powdered silicon at  $35^{\circ}$  and at 50 atm. If the ratios of  $H_2$  to silicon are controlled, any desired silane can be prepared from SiH<sub>4</sub> to Si<sub>5</sub>H<sub>12</sub>. For example: Using 190.8 L of H<sub>2</sub>, Tachiki obtained 95% SiH<sub>4</sub>. With 158.5 L of H<sub>2</sub>, 92% disilane was achieved, and with 120.5 L of H<sub>2</sub>, 98% Si<sub>5</sub>H<sub>12</sub> resulted. This work would have to be verified.

Gasper, Levy, and Adair [42] prepared trisilane by reducing  $Si_3Cl_8$  with LiAlH<sub>4</sub> in butyl ether in vacuum. All of these methods are used in development or in small-scale commercial uses.

### 2.4 POSSIBLE IMPURITIES AND IMPURITY LEVELS IN COMMERCIAL SILANES

To some degree, the impurities found in a product will be related to the purity of the starting materials. For silane, the silicon source is most likely related to metallurgical silicon; typical analyses are given in Appendix B. Since most of the silane made in the United States uses a chlorosilane, these impurities could be carried through into the silane. Note that the elements of Group III (B), Group V (P, As, Sb) and lots of heavy metals If silicon tetrachlorosilane is used, sources and possible are present. Here again, most of the elements impurities are as given in Appendix C. listed above would be present. Even if one uses silicon tetrachloride from the polysilicon effluent, contaminants from the reducing agents would introduce quite a few elements. Stone [40] studied the composition of silanes prepared by the magnesium silicide method. He found some 21 compounds could be present, including silane, and higher silanes up to SigH<sub>18</sub>. A typical process silane composition is given in Appendix A.

Almost all of the producers and sellers of silane indicated that they had a proprietary purification technique. However, they are generally considering only those impurities which are critical in current semiconductor uses. Analyses are typically run on silane for contained gases, nitrogen, oxygen, hydrogen, argon, chlorosilanes, carbon as monoxide or dioxide, and methane. Electrical properties are checked by deposition of a thin silicon layer on a silicon wafer. The resistivity of a standard electronic-grade wafer typically ranges from 50 to 150 ohm-cm. This property determines the quality grade. Several companies are advertising 1000 ohm-cm silane--the uniformity and use of this material will have to be determined. Incidentally, the resistivity of the epitaxial deposit does not directly correlate with what the silane would provide in a poly or amorphous deposition. It is not an indicator of the level of donors or acceptors.

Silane for semiconductor use is generally evaluated by the deposition of a very thin layer of silicon onto a single-crystal silicon wafer. The silicon grows on the same orientation (or axis) as the crystal in the wafer. Hence, the name epitaxial: same axis. The resistivity of the deposited layer is then measured to give a compensated resistivity. In silicon, the acceptors--normally boron--and the donors--normally phosphorus and arsenic--neutralize

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each other, atom for atom. Thus, we obtain the overall electrical measurement of resistivity and type. The type of resistivity is p (positive) for excess boron or n (negative) for excess phosphorus or arsenic. So, the boron level could be 10 ppba and the phosphorus level 8 ppba to give a 2 ppba excess of boron, setting the resistivity of 140 ohm-cm, p-type. Or it could also be 62 ppba of boron and 60 ppba of phosphorus for the same resistivity reading. One really needs to know actual levels of the impurities. It follows, then, that a resistance of 2000 ohm-cm on the deposited layer merely means that the difference in atoms is 0.12 ppba. In the single-crystal silicon area, high levels of B or P or any impurity can cause "dislocation" as the crystals grow. These can also cause uneven electrical properties.

The need for control or knowledge of the actual levels of elements in the silicon is yet to be determined for the amorphous area. Controlled levels of boron and phosphorus result in a more uniform product. Moreover, the presence of heavy metals can affect the long-term stability of the product. Group III (B) and Group V (P and A, etc.) analyses are not normally run on silane. Union Carbide suggests that these analyses are not easy to run and acceptable processes will have to be developed.

Brookhaven National Laboratory has run studies on the concentration of volatile impurities in selected cylinders of commercial silane and disilane. This work was performed under the auspices of the U.S. Department of Energy, Division of Materials Sciences, Office of Basic Science, under Contract DE ACO2 76CH00016. One segment of this study published recently [45] indicates that impurity levels of 20 ppm can affect the electronic properties of amorphous silicon cells. Further detailed data provided by R. Corderman [46] are given in Tables 2-1, 2-2, and 2-3 for silane and in Table 2-4 for disilane. These data indicate the wide range of impurity levels (from 10 ppm to 11,500 ppm) in various selected commercial silane products, and that filters can remove some of the impurities. These were proprietary filters, but it is known that chlorosilanes and siloxanes can be removed by passing the silane over activated charcoal. Corderman found that chlorosilanes in silane most likely react with moisture present to form siloxanes. Either one of these species can reduce the short-circuit current and the fill factor of amorphous photovoltaic devices. The newer, high-resistivity grades of silane generally show reduced impurity levels. A purer disilane should also be available soon.

From these data we can surmise that the following impurities could be present in commercial silane: atmospheric and rare gases, methane, carbon oxides, chlorosilanes, higher silanes, boron, phosphorus, antimony, and arsenic. The impurities in disilane would be expected to be the same as in silane, with the possible addition of higher order carbon compounds such as  $C_2H_4$ ,  $C_2H_6$ , and  $C_3H_8$ .

Most companies use gas chromatography to determine impurities, and epitaxial deposition for resistivity. Metal impurities are not normally run. One analysis showed quantities from 0.1 to 0.005 ppmw of iron, sodium, chromium, potassium, zinc, copper, nickel, lead, and tin. All commercial silanes seem to be n-type; that is, they yield n-type epitaxial films. This means the Group V elements--such as P and As--are dominant, which could be the reason that most amorphous silicon intrinsic layers are slightly n-type.

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Cylinder: Supplier: Grade:	Ml Matheson Semiconductor	M2 w/o Filter <sup>a</sup> Matheson Semiconductor	M2 w/Filter <sup>b</sup> Matheson Semiconductor	M3 Matheson Semiconductor	M4 Matheson Semiconductor
Species					
HC1	200	8,500	290	<b>9</b> 20	30
SiH <sub>3</sub> Cl	320	3,000	10		10
SiH <sub>2</sub> Cl <sub>2</sub>					
sicl <sub>4</sub>					
SiH <sub>3</sub> OSiH <sub>3</sub>	360	3,600	170	1,100	170
(SiH <sub>3</sub> 0) <sub>2</sub> SiH <sub>2</sub>		<b>19</b> 0	10	100	
SiH <sub>3</sub> (OSiH <sub>2</sub> ) <sub>2</sub> OSiH <sub>3</sub>		50			
Si <sub>2</sub> <sup>H</sup> 6	<b>9</b> 00	1,800	80	1,100	110
Total [C1]	520	11,500	300	<b>9</b> 20	40
Total [0]	360	3,840	180	1,200	170

Table 2-1.	Impurities	Detected	in Silane:	Cylinders	Ml through M4
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Source: Brookhaven National Laboratory

Note: All numbers are in ppm, with the measured data rounded to give two digits of precision; balance is  $SiH_4$  (10,000 ppm = 1%).

<sup>a</sup>Specially distilled to remove  $N_2$ .

<sup>b</sup>With proprietary filter between cylinder and mass spectrometer.

Cylinder: Supplier: Grade:	M5 Matheson Semiconductor	Il Ideal TOPS	I2 Ideal TOPS	M6 Matheson Purity	M6A Matheson Purity
Species					
HC1	210	10	620		60
SiH <sub>3</sub> Cl	50	20		10	
SiH <sub>2</sub> Cl <sub>2</sub>			400		
SiCl <sub>4</sub>			340		
SiH <sub>3</sub> OSiH <sub>3</sub>	260	20	100	90	<b>19</b> 0
(SiH <sub>3</sub> 0) <sub>2</sub> SiH <sub>2</sub>					
SiH <sub>3</sub> (OSiH <sub>2</sub> ) <sub>2</sub> OSiH <sub>3</sub>					1.00 v 100
Si <sub>2</sub> <sup>H</sup> 6	120	230	2 <b>,9</b> 00	60	<b>24</b> 0
Total [C1]	260	30	1,360	10	60
Total [0]	260	20	100	90	1 <b>9</b> 0

Table 2-2. Impurities Detected in Silane: Cylinders M5 through M6A

Source: Brookhaven National Laboratory.

Note: All numbers are in ppm, with the measured data rounded to give two digits of precision; balance is  $SiH_{4}$  (10,000 ppm = 1%).

ies Detected	in Silane: Cylinders	M7 through B3	
M8 <sup>a</sup> Matheson Purity	LC1 Liquid Carbonic CCD	Bl <sup>a</sup> Matheson Semiconductor	B3 <sup>a</sup> Matheson Purity
	*********		
	30	210	
	10	50	
30	80	270	

220

260

270

Table 2-3. Impurities Detected in Silane: Cyli	Inders M7	through	<b>B</b> 3
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Source: Brookhaven National Laboratory.

M7

Matheson Purity

280

0

0

Note: All numbers are in ppm, with the measured data rounded to give two digits of precision; balance is  $SiH_4$  (10,000 ppm = 1%).

180

0

30

----

50

40

80

<sup>a</sup>10% SiH<sub>4</sub> in UHP H<sub>2</sub>.

Cylinder: Supplier:

Grade:

Species

SiH<sub>3</sub>Cl

SiH2C12

SiH<sub>3</sub>OSiH<sub>3</sub>

(SiH<sub>3</sub>0)<sub>2</sub>SiH<sub>2</sub>

Total [C1]

Total [0]

SiH<sub>3</sub>(OSiH<sub>2</sub>)<sub>2</sub>OSiH<sub>3</sub>

SiCl<sub>4</sub>

Si2<sup>H</sup>6

HC1

12

**9**0

0

0

Cylinder: Supplier:	DS1 KOR Isotopes	DS2 Chronar	DS3 Chronar
Species			
HC1	540		-
Si <sub>2</sub> H <sub>5</sub> Cl	120		
co <sub>2</sub>			48 <b>,7</b> 50
SiH <sub>3</sub> OSiH <sub>3</sub>			6,200
Si <sub>2</sub> H <sub>5</sub> OSiH <sub>3</sub>		600	
(Si <sub>2</sub> H <sub>5</sub> ) <sub>2</sub> 0	860		
Si <sub>3</sub> H <sub>8</sub>	2,600	26,000	6,400
$Si_4H_{10}$	70	410	330
Total [C1]	660	0	0
Total [0]	860	600	54 <b>,</b> 950

### Table 2-4. Impurities Detected in Disilane

Source: Brookhaven National Laboratory.

Note: All numbers are in ppm, with the measured data rounded to give two digits of precision; balance is  $\text{Si}_2\text{H}_6$  and most likely some  $\text{SiH}_4$  (10,000 ppm = 1%).

### 2.5 PURIFICATION TECHNIQUES

A search of the Chemical Abstracts was made on purification techniques for the period 1960 to date. Some 24 references are reported in this subsection.

Monosilane has been prepared and used in the semiconductor industry for some twenty years. Most of the purity requirements were related to obtaining an epitaxial layer of silicon, where the electron donors and acceptors can be controlled. The major impurities of concern were those listed in the proposed SEMI standards C3STD8, 9, and 10, as shown in Appendix D. These specifications list the maximum parts-per-million levels of oxygen, hydrogen, water, carbon oxides, hydrocarbons as methane, chlorosilanes, and rare gases as 3 to 10,000.

These specifications relate basically to semiconductor uses. Specifications will have to be set up for silanes for solar energy uses. For example, hydrogen in the silane should not be a problem for solar cell uses. Some chlorosilanes may even be useful, since it has been reported that some halides enhance the ability of the deposited amorphous silicon to be easily doped. The level of Group III and V elements will probably be important, because they determine the electrical properties. Dissolved gases such as oxygen and the heavy metals in crystalline silicon determine the lifetime of the device, as these elements tend to combine with the useful elements. We presume that similar actions can occur in amorphous silicon.



The use of silane to produce polysilicon was considered in the early 1960s and prompted further investigation into purity. One U.S. company, Trancoa, operated a polysilicon plant for several years. They deposited silicon from silane on the external surface of an internally heated quartz tube. The quartz shattered upon cooling and was removed by acid leaching. The silane was made from the lithium hydride-silicon tetrachloride method. Around 1970, Komatsu began producing very pure silicon from silane.

Dr. Carlson and his team also studied the effects of various impurity gases in silane on glow-discharge-formed amorphous silicon [47]. His data are summarized in Table 2-5.

Of these contaminants, all showed some detrimental effect, but water, sulfide, phosphine, and chlorosilanes caused severe decreases in properties. The data also show that amorphous silicon can accommodate relatively large concentrations of impurities and still exhibit significant photovoltaic effect. Thus, a more pure starting material might be very useful, for it appears that the correlation of impurities in silane to cell properties is strong. In another report [48], Dr. Carlson's team found that carbon materials such as methane in silane cause increased resistivity, which lead to problems with contacts and lower solar cell performance. The Brookhaven data (in Section 2.4) indicate that all currently available commercial silanes contain various levels of impurities. Researchers should obtain a cylinder analysis from their suppliers.

Additional data on the effects of air, oxygen, nitrogen, phosphine, and monochlorosilane on amorphous silicon solar cells are given in an article by Delahoy and Griffith [74].

Impurity Gas (Vol. % of total atm.)	Voc (mV)	Jsc (mA/cm <sup>2</sup> )	Fill Factor
Nonecontrol	700	6.0	0.54
2.3% H <sub>2</sub> 0	400	0.6	0.23
2.3% H <sub>2</sub> S	425	3.0	0.21
1.0% GeH4	370	3.0	0.21
10% CH <sub>4</sub>	662	4.0	0.53
30% CH <sub>4</sub>	230	0.02	0.18
10% N <sub>2</sub>	595	6.0	0.55
0.06% PH3	130	1.5	0.42
50% SiH <sub>2</sub> Cl <sub>2</sub>	321	0.05	0.25

# Table 2-5. Photovoltaic Properties: The Effect of Impurity Gases in Silane

### 2.5.1 Properties of Silane

The basic properties of silane are listed in Appendix E. The various silanes have a wide range of boiling points. Early workers found it easy to separate monosilane from the di- or trisilanes by cooling the mixture below  $-130^{\circ}$ C and then taking off each species as it warmed up to its boiling point.

Silane is generally listed as spontaneously flammable in air. My experience is that very pure monosilane does not spontaneously ignite in air. Most probably, all monosilane contains some di- or trisilane, which does ignite on exposure to air. Silane does not react with neutral water, ammonia, or metal hydrides. It will react with halogens, bases, and alcohols and will reduce salts to their base metal. Silane is ordinarily stable at temperatures up to  $380^{\circ}-400^{\circ}C$ . These properties allow several different purification processes, unique to silane, to be used. A further listing of properties is given by Yaws et al. in his article "Physical and Thermodynamic Properties of Silane," published in the January 1978 issue of <u>Solid State Technology</u>.

### 2.5.2 Purification Processes

The various techniques for purifying silane involve selective reactivity, selective sorption, distillation, or a combination of these.

- 1. Chalupa et al. [51] found that scrubbing crude silane with a solution of sodium and liquid ammonia produced a product suitable for manufacturing semiconductors (1961).
- 2. Lewis et al. [52] reporting on an Air Force-sponsored study by Metal Hydrides, Inc. and Cambridge Labs, lists several techniques for purifying silane. A liquid ammonia scrubber is suggested for removing boron complexes. Activated carbon, at temperatures below zero, is an adsorbent for diborane and arsine. (This should also remove other polar molecules--phosphine and chlorosilanes.) Passing silane through a hot tube at 350°C should decompose hydrides of germanium, lead, gallium, and antimony. After these treatments, silane with only ppb impurities resulted.
- 3. A British patent [53] states that silane can be freed from arsine by passing it through activated carbon in a vessel at  $-78^{\circ}$ C, imbedded in solid CO<sub>2</sub>. Diborane can be removed by passing it through the same material at 0° to  $-30^{\circ}$ C. The saturated charcoal may be reactivated by flushing it with argon at  $200^{\circ}$ C.
- 4. Caswell and LeFever [54], in a German patent, treated silane with finely divided metals (Li, Rb, Cs, Ba, Sr, or Mg) to remove boron. The boron complex  $(B_2H_62Na)$  is easily removed. The reactive metal can be on an adsorbing agent as a carrier, such as sodium on silica gel, on activated alumina, or on a crystalline zeolite.
- 5. A Netherlands patent [55] states that 98% silane, with impurities of hydrogen, chlorosilanes, silicon tetrachloride, helium, siloxane, disilane, arsine, phosphine, and diborane is purified by distilling it



at  $-10^{\circ}$  to  $-70^{\circ}$ C into porous wood charcoal and then into porous magnesium silicate at  $-40^{\circ}$  to  $-80^{\circ}$ C. The impurities come off the top; the silane, off the bottom. This is then passed through granular wood charcoal at  $-10^{\circ}$  to  $-50^{\circ}$ C. The resulting silane is "practically" pure.

- 6. As ano et al. [56] used carbon and a synthetic zeolite of 0.5 to 0.9 nm pore size to remove ethyl and ethoxy impurities from their silane prepared from triethoxysilane. Less than 0.2 ppm of these impurities remain in the silane.
- 7. Cowlard [57] states that crude silane can be purified by passing it through a molecular sieve above 0°C. He suggests a type 5A, 13X mixture of synthetic zeolites. The purified silane gave a deposited silicon of 100 ohm-cm, p-type. (Data on Linde molecular sieves is listed in Appendix F.)
- 8. Ohgushi et al. [58] explain the molecular sieving action on an ion exchange zeolite A. Using a potassium A zeolite, they exchanged the cation with divalent metal elements and determined the adsorption of phosphine from silane. A mechanism is proposed.
- 9. Takaishi and Gomi [59] have suggested a compact purifier for silane to remove what they believe to be the major impurity in commercial silane--phosphine. They advocate the use of potassium-zinc A zeolite which, they state, selectively adsorbs phosphine. They passed 1-3 L/min of a 5/95 mixture of silane/hydrogen through the zeolite column at  $-20^{\circ}$ C. The impure silane gave a silicon film of 0.7 ohm-cm; the treated silane gave an epitaxial silicon film of 3000 ohm-cm.
- 10. Schoellner [60] claims in an East German patent that a 50:50 mixture of silane and phosphine, mixed with nitrogen to a phosphine volume % of 5, was passed through a sodium-magnesium A zeolite and the phosphine was completely removed. The phosphine recovered from the zeolite contained only 0.18 volume % silane.
- 11. Caswell [61] patented a process to purify silane by means of a synthetic zeolite system to remove arsine and phosphine.
- 12. In a Russian patent, Lebedev [62] claims purifying silane by passing it through a sorbent of 20%-40% aqueous collodial solution of silica with 1% ammonia.
- 13. Yatsurugi et al. [63] in a German patent describe a new ion exchanged zeolite--specifically for removing phosphine from silane. This is a zeolite in which 30%-83% of the ions are replaced by potassium and 16%-66% of the exchangeable calcium is replaced by divalent ions from the group: Mg, Zn, Cd, Pb, and Mn.
- 14. Kuratomi and Yatsurugi [64] developed a zeolite of fine pore size to purify silane. The sodium of the zeolite is replaced with zinc or lead. In a companion patent [65] they used a lithium ion to replace the sodium.

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- 15. Takaishi et al. [66] studied the properties of molecular sieves, where the sodium and potassium were replaced with calcium or zinc. The functionality of purifying silanes was measured against their composition.
- 16. Yusa, Yatsurugi, and Takaishi [67] report that silane made by reacting magnesium silicide and ammonium chloride in ammonia contains diborane, arsine, phosphine, methane, carbon oxides, and nitrogen. A new zeolite with zinc and potassium ions was made from a Linde 4A molecular sieve. Silane purified with this system gave a deposited silicon of 1000 to 8000 ohm-cm.
- 17. LeFever [68] states that treating silane with ammonia removed boron hydride and halide impurities. Silane and ammonia are condensed together and heated to  $25^{\circ}$ C at 400 psig. The impurities form non-volatile coordination compounds. The excess ammonia is fractionated or adsorbed at  $-78^{\circ}$ C on synthetic sodium zeolite A. Silicon deposited from this silane had a resistivity of 300 ohm-cm (less than 5 ppba boron).
- 18. Tarancon [50] in his 1978 patent details a process for the purification of silane involving passing the impure silane through a succession of six zones connected in series. He lists a typical process silane as having 97%-98% by weight monosilane; 1.5%-2.5% hydrogen, chlorosilanes, and silicon tetrachloride; 0.5% helium, silicones, higher silanes, arsine, phosphine, and diborane. This appears to be a silane prepared by the hydride-silicon tetrachloride method. The process is carried out in a closed system to preclude air or moisture. The impure silane is passed through the following zones:
  - a. A stainless-steel packed column at 8 psig--removes silicon tetrachloride.
  - b. Activated charcoal at  $-70^{\circ}$ C, 7 psig--removes chlorosilanes and silicones.
  - c. "Florisil" at -70<sup>o</sup>C, 6 psig--removes arsine and phosphine. (Florisil is magnesium silicate from the Floridin Company.)
  - d. Stainless steel packed column at -24°C, 100 psig--removes low boilers, gases, and lites.
  - e. Empty column at -195°C, 2 psig--freezes out the silane.
  - f. Activated charcoal at 20°C, 100 psig--removes diborane and higher silanes.

Tarancon claims the treated product is 99.99% pure monosilane. The product is compressed to 1500 psig for packaging.

19. Hartford [69] and Clark [70] and their coworkers at Los Alamos Laboratories describe a silane purification method based on laserinduced chemistry. By selective photolysis, quantum yields for the

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destruction of arsine, diborane, and phosphine are claimed. With a 193-nm argon-fluoride excimer laser, at ambient temperature, 50 ppm of arsine and phosphine in silane were reduced to less than 0.5 pmm. The impurities were preferentially dissociated and deposited as metal or as polymer on the filters.

- 20. In a 1965 patent, Bradley [71] claims the purification of chlorosilanes or silane by adding elemental iodine, bromine, or chlorine and distilling. This is said to remove all of the phosphine and arsenic and some of the boron and sulfur. While this technique has been demonstrated with chlorosilanes, its usefulness with silanes would have to be confirmed.
- 21. Coleman [72,73] reports the preparation of ultra-high-purity silane by using a recycle system in the separation columns. In preparing trichlorosilane for redistribution to silane, he reports that a small amount of silane is fed into the feed system at the stripper column in which chlorosilanes and silicon tetrachloride are separated. The silane at these temperatures reacts with the chloride impurities to form hydrides. Thus, any arsine, phosphine, or boron present as chlorides would be converted to volatile hydrides, which are removed with the other light fragments in the column. This process would be usable only if the investigator were running the total Union Carbide silane process, however (see Section 3.0).

We can conclude that no one process will completely purify silane. On a research level, the use of charcoal, molecular sieves, and perhaps some ammonia traps should yield a fairly pure silane, however, based on the references cited here. Of course, it is desirable to start with the most pure silane available. But note that silane should be handled even at a research level only by experienced personnel. Manufacturers of silane are unanimous in recommending that users not try to purify silane. They suggest that only a filter be used to remove particulate matter. It is suggested that needs for improved silane should be discussed with a supplier. See in particular Tarancon [50]. This patent lists the various filters and the impurities that are removed by each filter. Note that the used filters (saturated with silane) must be properly disposed of. A higher-purity silane may be available by 1984, both from current suppliers and from the new Union Carbide plant.

### 2.6 COMMERCIAL AVAILABILITY

To determine the commercial status of silanes in the United States, fifteen companies who could make and/or sell them were sent a questionnaire that requested preparation methods, analysis capability, and typical purity, as well as literature, pricing, and grades. This was followed up with one or more telephone calls to confirm data. The comments reported here are those submitted by the companies.

Seven of the U.S. companies contacted indicated they are or can be prime producers of monosilane. It appears that some companies buy some or all of their SERI 🛞

requirements, depending on volume and available supply. The current U.S. companies that produce and sell silane are

- Airco Industrial Gases
- Linde Specialty Gases, Union Carbide Corporation
- Air Products and Chemicals, Inc.
- Liquid Carbonic Corporation
- Matheson Division, Searle Medical Products Corporation
- Scientific Gas Products, Inc.
- Synthatron Corporation.

Allied Chemical Company indicated that it can produce silane and is considering entering the market.

Companies that only sell silane are Ideal Gas Products, Inc., and M. G. Scientific Gases. Disilane is produced and sold by Chronar Corporation (sold by Airco), Matheson Division, and Synthatron Corporation. Several additional companies indicated interest in making disilane, if the market develops. The list of companies contacted and their addresses is given in Appendix G.

No producer was willing to give details on his methods of producing silanes. This is a competitive business and all undoubtedly have their own methods of purifying products. Based on literature, patents, and industry awareness, there are probably three basic processes used commercially to prepare silane:

- 1. Lithium or sodium hydride with a silicon halide
- 2. Magnesium silicide with a mineral acid
- 3. Catalytic redistribution of chlorosilanes.

There are many variations of the processes, but the most often mentioned process in the United States seems to be Method 1. Union Carbide is using Method 3 at their Washington plants.

For disilane, one could use Method 2 above, in which a mixture of silanes usually results. Lithium aluminum chloride with hexachlorodisilane could also be used. A new process involves passing silane through an electrical discharge. This method should produce disilane as pure as the starting silane. Several companies are actively working in this area and could well be developing new methods. We believe that Chronar is using the magnesium silicide process for their production of silane and higher silanes, but is also developing the improved methods for producing a purer disilane. Because disilane can decompose at room temperatures into silane and hydrogen, the material should be analyzed before use.

References are given in the preparation section of this report on the methods for making silanes. Products of all these methods require some purification, however, to improve the quality. Currently, silanes are used in the United States basically in the semiconductor market. Production and sales have been in the millions of grams and distribution has been in gas cylinders. If amorphous silicon solar cell production begins soon, however, larger volumes will



probably be needed. Scale-up of the hydride or silicide processes could be a problem. The new Union Carbide process should be able to provide bulk silane, if needed, subject to the company's own internal requirements for polysilicon production. The company estimates that it will have the ability to meet any customers' needs, provided that it has adequate lead time.

There are three major grades of silane available: epitaxial, silicon nitride, and charged couple device (CCD). Some companies offer two grades, others offer up to five. Proposed SEMI specifications are given in Appendix D. Epitaxial grades are around 100 ohm-cm. The types over 1000 ohm-cm are usually of the CCD variety. For silicon nitride, silane is reacted with ammonia; thus, chlorosilane and methane contents should be under 10 ppm. Epitaxial grade silane usually allows up to 1000 or 10,000 ppm of chlorosilanes. Most commercial silane today provides n-type epitaxial silicon; that means the phosphorus and arsenic impurities are greater than the boron or aluminum. Other high-resistivity grades are coming on the market; these should be evaluated carefully for solar cells, because impurities are as important as resistivity.

U.S. sales of silane in 1982 were probably over 40,000 kg or 40 metric tons. This market should follow the semiconductor industry growth curve. In 1983, sales should exceed 45 tons.

### 2.6.1 Additional Comments on Silane Producers

#### 2.6.1.1 Airco Industrial Gases

Airco makes and sells silane and disilane; it may also purchase part of its needs. The company has its own methods of purifying silane made by a lithium hydride-chlorosilane process. It also has a contract with Chronar to distribute disilane and to do quality-control work. They offer nitride-grade silane of 1500 ohm-cm, with the following maximum ppm: oxygen, 1; nitrogen, 25; chlorosilanes, 1; CO, 2; water, 1; argon, 1; hydrogen, 200; methane, 1; and heavy metals, ppt. 1500 ohm-cm silane is offered at \$1.20/g. Disilane is \$65/g in 25-g sizes, \$55/g in 100-g sizes.

### 2.6.1.2 Allied Chemical Company

Allied is not currently producing silane. However, it does have a pilot plant based on the LeFrancois patent (silicon tetrafluoride plus sodium hydride).

#### 2.6.1.3 Air Products and Chemicals, Inc.

Air Products makes and sells silane prepared by the lithium hydride plus silicon tetrachloride method. It offers nitride or epitaxial-grade silane, which equals or exceeds the proposed SEMI specifications, and is greater than 100 ohm-cm. A typical lot would have these ppm impurities: hydrogen, 500; methane, 10-40; HCl, 10-20; CO, 5; nitrogen, 40; rare gas, 40; and water, 1. The company does a complete analysis on each lot, including epitaxial resistivity. It suggests that customers not try to purify silane, but will discuss special needs with them.

### 2.6.1.4 Chronar Corporation

Chronar is making silane and disilane basically for its own solar cell production. Excess capacity will be sold through Airco. The quality of the product reported in the Brookhaven data (Section 2.4) was early production. The company reports they have now improved the quality of their products, especially disilane, which is made by a new process.

### 2.6.1.5 Liquid Carbonic Corporation

The company makes and sells silane, producing it by means of a proprietary process. A 1978 news release states "Liquid Carbonic has been operating the largest silane-producing facility in the U.S. at San Carlos, Ca. They recently completed an expansion which will double plant capacity." Five grades of silane are offered: epitaxial, 100 ohm-cm; polysilicon or oxide grade, 50; silicon nitride, 50; charged couple, 200; and HRS, 400. Typical impurities: hydrocarbons, 10 ppm, CO, 10; hydrogen, 500; and nitrogen, 100. A special resistivity analysis will be run for \$200 each. The company recommends only using a filter for particulates.

### 2.6.1.6 Matheson Gas Products, Inc.

Matheson makes and sells silane and disilane by a proprietary method. It has two grades of silane: semiconductor-100 ohm-cm, priced from 0.24 to 0.88/g; and Matheson purity, 1000 ohm-cm, priced from 0.95 to 1.30/g. Disilane is sold in 100-g cylinders at 45/g. Matheson is developing a new process and expects to sell disilane for under 20 in 1984. Quality control is basically epitaxial deposition and gas chromatography. The Matheson purity grade has under 10 ppm chlorosilanes. Customers can also request special qualitycontrol tests. The disilane is 99+% pure, with some hydrogen, chlorosilanes, and silane. A new process for disilane is now under development that should yield a purer disilane.

In June 1983, G. D. Searle & Company announced the sale of its Matheson Gas Products operations in the United States and Canada to a joint venture formed by UGI Corporation's Amerigas subsidiary and Nippon Sanso K. K. of Tokyo. Earlier, Searle announced the sale of its Matheson European operation to Union Carbide Benelux N.V. The U.S. operation will be known as Matheson Gas Products, Inc.

### 2.6.1.7 Scientific Gas Products, Inc.

This firm makes and sells silane and disilane, using hydrogenation of trichlorosilane. Some material is purchased and purified for sale. They sell two grades of silane: epitaxial, 100 ohm-cm, and nitride grade, 50 ohm-cm. The epitaxial grade has these maximum ppm: nitrogen, 40; oxygen, 10; methane, 40; hydrogen, 1000; water, 3; chlorosilanes, 1000; and rare gases, 40. The nitride grade has the chlorosilanes reduced to 10 ppm. Scientific prices silane from \$0.95/g for 100 g to \$0.36/g for 5000 g. It does not suggest that

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the customers try to purify the silane, only that they use a filter to remove any oxide formed in the lines. No special analyses are offered.

### 2.6.1.8 Synthatron Corporation

Synthatron makes and sells silane and disilane produced by means of a proprietary process and purified by its own technique. It offers several grades of silane; the best grade would have these ppm maximums: nitrogen, 100; oxygen, 1; water, 2; hydrogen, 50; CO, 10; methane, 5; argon, 5; and chlorosilanes, 5. Disilane has this typical profile of impurities: hydrogen, 0.5-1.6%; nitrogen, 50 ppm; oxygen, 50; argon, 50; CO, 50; CO<sub>2</sub>, 20; methane,  $10; C_2H_6$ , 10; chlorides, 0.5%. Complete cylinder analysis costs \$125. Customers are discouraged from trying to run their own purification processes.

### 2.6.1.9 Union Carbide Corporation, Linde Division

Linde Specialty Gas Products makes and sells silane prepared by a proprietary method. They offer an electronic grade of 100-150 ohm-cm. Typical impurities are in maximum ppm: chlorosilanes, 50; hydrogen, 200; methane, 50; nitrogen, 100; and some water and oxygen. They will run a special resistivity analysis for \$100. Linde expects to introduce an "Ultra Plus" grade of silane soon, yielding a deposited film of over 1000 ohm-cm. It recommends that customers not try to purify silane themselves.

### 2.6.1.10 Ideal Gas Products, Inc.

Ideal sells monosilane and disilane. It gets its silane from Certified Gas and Controls, Inc. Ideal uses a proprietary purification process to make a CCD grade silane, which it calls "thousand-ohm-plus silane," or TOPS. Each lot is evaluated using advanced in-house methods. It also offers an electronic grade, presumably around 100 ohm-cm. The impurity levels in TOPS grade silane were given as 1-5 ppm moisture, 2-5 ppm methane, 20-600 ppm hydrogen, and 5-100 ppm nitrogen. The uncompensated epitaxial deposited silicon can be up to 2500 ohm-cm resistivity. Spreading conductance measurements can also be Heavy metals are typically less than ppt. taken. Ideal does run the SEMI specification tests and will do custom analysis for customers, sufficient to qualify the silane for its intended use. Disilane is also sold, but the impurities are not listed. Ideal does not suggest further purification by customers, but does suggest that chemically cleaned gas handling equipment be used.

Silane price ranges, as reported by the companies in July 1983, are listed in Table 2-6. These are the list prices, generally for 100-g to 10,000-g or larger cylinders. These prices are for reference only. Customers should get direct quotes for the quality and quantity they need. Disilane is generally available only in 50- or 100-g cylinders.

Company	Grade Name	Price Range (\$/gram)
Airco	Nitride CCD 1500 Disilane	0.32-0.71 1.20-1.50 55.00-65.00
Air Products	Nitride Semiconductor	0.50-0.75 0.29-0.90
Linde-UCC	Semiconductor Ultra Plus <sup>a</sup>	0.17-0.41 0.50-1.00
Liquid Carbonic	Epitaxial Nitride, CCD HRS-400	0.16-1.38 0.16-1.30 0.16-1.30
Matheson	Semiconductor Matheson Purity Disilane	0.24-0.88 0.95-1.30 45.00 <sup>b</sup>
Scientific Gas	Epitaxial Nitride VLSi	0.36-0.95 0.43-1.15 1.30-2.78
Synthatron	Polycrystalline Epitaxial, Nitride Disilane	0.30-1.00 0.30-1.00 85.00-130.00
Ideal Gas	Electronic TOPS	0.34-0.85 0.61-1.50

Table 2-6. Silane Prices (U	<b>.S. list</b> , July 1983)
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<sup>a</sup>Available in Fall 1983.

<sup>b</sup>Expected to be in \$20 range in 1984.

Note: Cylinder sizes of 100, 1000, 3000, and 5000 g are common, with 10,000, 12,000, or 16,000-g sizes available from some companies. These are published prices only. Actual prices must be obtained from each company. Note also that there is a cylinder lease or rental charge.

### 2.6.2 Silane Data Sheets

Representative data sheets are attached to this report as Appendix L. This is not intended to be a complete collection of all possible data sheets, however. Sheets are included for the following:

- Airco Industrial Gases
- Air Products silane specifications
- Ideal Gas silane specification and prices
- Linde silane product information sheets
- Liquid Carbonic silane specifications

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- Matheson Tech Brief on high-purity silane
- Matheson disilane
- Scientific Gas Products sheet
- Synthatron specifications.

These sheets should provide an indication of the types of silanes commercially available.

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### SECTION 3.0

### REVIEW OF THE JPL/UCC CONTRACT--SILANE FOR POLYSILICON PROJECT

### 3.1 INTRODUCTION

In 1975, the Jet Propulsion Laboratory (JPL) was selected by the U.S. Government (first by ERDA, and later the Department of Energy) to contract and manage the Low Cost Solar Array Project (LCSA) under the overall renewable energy program. Union Carbide Corporation (UCC) was one of the twelve companies funded to work on less costly methods for making polysilicon. The objective of this contract, No. 954334, was to develop the silane process technology for the manufacture of polysilicon in a large commercial plant in 1986, at a price of not more than \$10/kg (1975 dollars).

Union Carbide had been interested in silicon chemistry since the 1930s when they began research on silicones. This work was interrupted by World War II assignments on the atomic energy program. Research continued sporadically over the next 30 years and included silane work. UCC produced silane by the trichlorosilane-ethanol process in 1955 and by the molten salt process in 1957. It has continued to be one of the largest current producers of silane. In 1967, UCC's Silicones Division began producing dichlorosilane, using a UCC patented process. Patents were also issued to UCC for producing silane. These processes were used later in the JPL programs.

### 3.2 SCOPE OF THE JPL CONTRACT

The objective of the Phase I program was to conduct feasibility research to establish the practicality of three concepts:

- High-volume, low-cost production of silane, as an intermediate for high purity silicon
- Pyrolysis of silane to silicon in a free space or a fluid bed reactor
- Use of capacitive heating of a fluidized bed.

### 3.3 SUMMARY OF THE PROCESS AND DESIGN WORK

A small process development unit was designed, constructed, and operated in 1975-1977 to demonstrate the conversion of dichlorosilane or trichlorosilane to silane.

Phase II was authorized in 1977, to provide an information base and to do a preliminary design for an experimental process design unit (EPSDU or pilot plant) sized for 100 tons of silicon per year.

Phase III was authorized in 1979 for UCC to design, construct, and operate the EPSDU unit for one year. This program was terminated in 1981, before any of the purchased equipment could be assembled. Union Carbide then negotiated


with the Department of Energy to obtain this equipment in order to complete the silane part of the unit with corporate funds. They then moved the EPSDU equipment from the East Chicago site to another company location at Washougal, Washington. This unit is now part of the Electronics Division Materials Technical Center at that location. Government funding continued in 1983 on Phase IV, with limited work on fluid bed decomposition of silane.

In the fall of 1980, Union Carbide Corporation approved the construction of a 1000-metric ton plant to produce polysilicon from silane. The technology needed to decompose silane was purchased from the Komatsu Electronic Metals Company, Ltd, a subsidiary of Komatsu, Ltd. Engineering studies were begun in 1981; ground was broken at the Moses Lake, Washington, site on July 6, 1982; and initial production is scheduled for late 1984.

## 3.4 DESCRIPTION OF THE SILANE PROCESS

A simplified flow schematic for the overall process to make silane and polysilicon is shown in Figure 3-1. This process converts 98% metallurgical grade silicon to trichlorosilane (TCS) in a hot fluid bed reactor fluidized with a hot, equimolar hydrogen/silicon tetrachloride (STC) gas feed. The hot vapor product from the reactor, which contains 15% trichlorosilane, is quench-cooled to its dew point to reject heavy metal chloride contaminants. The product is fed to a stripping column which frees the liquid of dissolved gases. In the TCS distillation column, the liquid is separated into silicon tetrachloride for recycling and an overhead product of trichlorosilane and lites. The overhead product is further processed in a second distillation column to separate trichlorosilane off the bottom. The trichlorosilane is recycled to the first distillation column through a catalyst in the redistribution reactor that partially converts it to silicon tetrachloride and dichlorosilane. **Overhead** product from the second distillation column, dichlorosilane and lites, is fed through another catalytic redistribution reactor, which partially converts it to silane. The silane mixture is processed through the final silane polishing column.

Ninety-eight percent pure, powdered metallurgical grade silicon, with an average particle size of 300 microns, is fed from a storage bin to a catalyst A small amount of copper catalyst can be added blender (see Figure 3-2). here. This mixture is fed into the fluid bed, hydrogenation reactor, operating at some 482°C and 500 psia. A recycle stream of hydrogen and silicon tetrachloride, in equimolar parts, is preheated to over 510°C before entering the reactor. Make-up hydrogen is added from the pyrolysis reactor or from a storage tank. The hot vapor product contains some 15% TCS, 44% hydrogen, 41% STC, and some silicon dust. All of the trace metal contaminants from the feed silicon are also present as metal chlorides. This is quenched and moved to a settler tank. Many of the metal contaminants settle out as insoluble com-A small stream is bled off the bottom of the settler to remove these pounds. Hydrogen is removed and recycled to the hydrogenation reactor. solids. The crude TCS/STC is moved to a storage tank.



Source: Final report, Low Cost Solar Array Project, JPL/UCC Contract No. 954334, 1979.

## Figure 3-1. Flow Schematic of the Union Carbide Silane Process, Ultra-High-Purity Silicon Plant

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Source: Final report, Flat Plate Solar Array Project, JPL/UCC Contract No. 954334, 1981.

## Figure 3-2. Block Flow Diagram of the Silane-Silicon Process

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The crude TCS/STC mixture is then fed to a stripper column to remove all volatile contaminant gases lighter than silane to at least 0.01 ppb and to remove 99% of the heavy volatile contaminants. The crude TCS/STC is fed to the second column, which also receives a recycle stream from the first redistribution reactor. This column should separate 97% of the TCS overhead and reject 97% of the STC as bottom liquid for recycling.

The trace metal contaminants--PCl<sub>3</sub>,  $AsCl_3$ ,  $FeCl_3$ ,  $NiCl_2$ ,  $CuCl_2$ , and  $CaCl_2$ -have a higher boiling point than the TCS and thus will be rejected with the STC and eventually removed as sludge from the settler tank. If any of these metals are present as hydrides, they will still be with the TCS.

The TCS, which also has monochlorosilane and dichlorosilane (DCS) with it, is fed into the third column, along with a second feed from the recycle of the silane column. This is set to deliver 97% of the TCS to the bottom and 97% of the DCS to the top as distillate. The bottom product is cooled and fed through a Rohm and Haas Amberlyst A-21 amine base ion exchange resin in the catalytic redistribution reactor. This reactor catalyzes the following reactions:

 $2HSiCl_3 = H_2SiCl_2 + SiCl_4$  $2H_2SiCl_2 = H_3SiCl + HSiCl_3$  $2H_3SiCl = SiH_4 + H_2SiCl_2 .$ 

The DCS is cooled and passed into a second redistribution reactor similar to the first. This product is fed into the fourth column, which separates out some 11 mol % silane. The silane product is stored as liquid for evaluation, cylindering, or to supply the pyrolysis reactors.

## 3.5 CALCULATED PROCESS IMPURITIES

The primary source of impurities is the metallurgical silicon raw material. Other impurities could enter with the copper catalyst, hydrogen, nitrogen, or silicon tetrachloride. The amounts of impurities possible and their sources and exit points in the process are shown in Table 3-1. The boiling points of the various possible compounds in the stream are listed in Table 3-2. These data indicate that separation by distillation should be possible.

Theoretical calculations suggest a possible silane purity of less than 0.05 ppb of the Group III or Group V elements, with some hydrogen. This is based on the process operating continuously at equilibrium.

## 3.6 SPECIAL PURIFICATION PROCESSES

In the process, there are redundant purification techniques to ensure the purity of the silane product. Three of these techniques have been featured in the NASA Tech Briefs (Purification Section 24). Copies of these briefs are attached as Appendices H, I, and J.

Element or	Amount Entering per Amount Product lb. moles/lb. mole		Entry Point, Percentage of Total Compound Entering				Exit Point ('X' indicates compound is present)	
compound			Metal Grade Silicon	Cement Copper	Hydrogen	STC	Waste Chlorides	Stripper Column
Aluminum	3.25	$\times 10^{-3}$	96.5%	1.1%		2.5%	X	
Antimony	2.63	× 10 <sup>-6</sup>	81.0	16.2		2.8	Х	
Argon	6.43	$\times 10^{-5a}$	0.4		99.6			X
Arsenic	4.19	$\times 10^{-6}$	81.0	16.2		2.8	Х	Х
Boron	1.01	$\times 10^{-4}$	100.0			<0.1	Х	Х
Calcium	4.68	$\times 10^{-4}$	100.0				Х	
Carbon (C)	1.3	$\times 10^{-3}$	100.0				Х	
Carbon Dioxide	2.42	$\times 10^{-6}$	0.3		99.7			Х
Chromium	1.20	$\times 10^{-4}$	100.0				Х	
Copper	9.60	$\times 10^{-3}$	0.6	99.4		<0.1	Х	
Helium	6.05	$\times 10^{-5}$			100.0			Х
Iron	3.10	$\times 10^{-3}$	99.9	0.1	<b></b> ,	<0.1	Х	
Lead	4.2961	$\times 10^{-6}$	25.2	74.0		0.8	Х	
Magnesium	2.16	$\times 10^{-4}$	99.2	0.8			Х	
Manganese	1.14	$\times 10^{-4}$	100.0			<0.1	Х	
Methane	1.94	$\times 10^{-6}$	0.7		99.3			Х
Me <sub>2</sub> SiCl <sub>2</sub>	9.678	$\times 10^{-40}$				100.0		Х
Nickel	3.96	$\times 10^{-5}$	100.0			<0.1	Х	Х
Nitrogen (N <sub>2</sub> )	2.01	$\times 10^{-2c}$	6.2		0.2	93.6		Х
$0xygen (0_2)^{2}$	4.18	$\times 10^{-30}$	59.7	39.3	0.7	0.3	Х	
Phosphorus	2.01	$\times 10^{-4}$	100.0			<0.1	Х	Х
Sulfur	7.19	$\times 10^{-5}$	7.0	93.0			Х	Х
Titanium	2.21	$\times 10^{-4}$	83.9			16.1	Х	
Vanadian	1.22	$\times 10^{-4}$	99.4			0.6	Х	
Zinc	4.81	× 10 <sup>-6</sup>	100.0				Х	
Zirconium	8.25	× 10 <sup>-5</sup>	77.7			22.3	Х	

Table 3-1. Process Impurities for Union Carbide Silane

<sup>a</sup>Argon does not include pyrolysis purge quantities.

Typical organic-chlorosilane. Decomposes to methane and chlorosilanes.

<sup>C</sup>Includes dissolved nitrogen in inert gas padding on STC storage tanks.

dIncludes oxygen content of moisture. Reacts to form oxides.

Source: Final report, Low Cost Solar Array Project, JPL/UCC Contract No. 954334, 1979.

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ormal Boiling Point ( <sup>O</sup> C)	Formula	Compound
1 <b>3</b> 0	AsC13	Arsenic chloride
-55	AsH <sub>3</sub>	Arsenic hydride
+12.5	BC1 <sub>3</sub>	Boron chloride
-96.5	B <sub>2</sub> H <sub>6</sub>	Boron hydride
+76	PC1 <sub>3</sub>	Phosphorous chloride
<del>-</del> 85	PH3	Phosphorous hydride
<b>-6</b> 0	H <sub>2</sub> S	Hydrogen sulfide
-112	SiH <sub>4</sub>	Silane
-30.4	H <sub>3</sub> SiC1	Monochlorosilane
+8.6	H <sub>2</sub> SiCl <sub>2</sub>	Dichlorosilane
+31.8	HSIC13	Trichlorosilane
+56.7	SiCl <sub>4</sub>	Silicon tetrachloride
+5	siCl <sub>4</sub>	Silicon tetrachloride

Table 3-2. Union Carbide Silane Process Compound Relative Volatility Factor

Source: Final report, Low Cost Solar Array Project, JPL/UCC Contract No. 954334, 1979.

## 3.6.1 Controlled Distillation

It is possible that certain contaminants of intermediate volatility could become trapped in sections of the distillation system. For example,  $BCl_3$ , whose boiling point falls between those of DCS and TCS, will go with the overhead distillate product in the TCS column, enter the DCS column, and be rejected to the bottom products. Thus, it is possible that the concentration of  $BCl_3$  could build up in the system and carry over into the product. To prevent this, small bleed streams are designed in the system to provide an exit path from the system. Thus, the closed-loop process can be operated for maximum economies of conservation of chlorine, hydrogen, and minimum waste disposal (see Appendix H).

#### 3.6.2 Converting Metal Chlorides to Volatile Hydrides

When the crude products from the hydrogenation reactor are run through the stripper to remove most of the silicon tetrachloride for recycling and to vent off the light waste gases, impurities such as arsenic, phosphorus, and boron chlorides would stay with the TCS cut. These would impose a heavier load on the downstream processing equipment. A new patent, issued in 1982, presents the technique used in the UCC process. A small amount of silane is fed into the bottom of the stripper column. The silane reacts with the Group III and V chlorides to form hydrides of arsenic, boron, and phosphorus. These volatile compounds are readily removed with the light gas wastes. Only 10 to 100 ppm of silane need to be diverted from the final silane column to the stripper to convert the 1 to 10 ppm of impurity chlorides (see Appendix I).

## 3.6.3 Use of Multi-Passes through the Catalytic Redistribution Reactors

The resin catalyst used in these reactors is functionally a tertiary aliphatic amine. Any boron compound that travelled this far in the process stream should form a complex with the amine and be removed. The continuous-flow, closed-loop system provides several passes through the equipment (see Appendix J).

## 3.6.4 Final Distillation

The final distillation column is keyed to remove any boron hydride which has survived all the other traps. Diborane boils at  $-93^{\circ}$ C, while silane boils at  $-112^{\circ}$ C. The column can be operated to produce a silane product with less than 0.01 ppb diborane, even if the column feed contains up to 5 ppm.

## 3.7 COMMERCIAL AVAILABILITY

The Union Carbide Washougal plant was started up in early 1983. It is expected that it will make silane available to be marketed by the Linde Division by the Fall of 1983.

While complete analyses of the silane have not been run, we can calculate a derived purity from the analysis of the deposited layer of polysilicon. Polysilicon produced in March of 1983 at Washougal was analyzed as follows: boron, 0.021 ppba; phosphorus, 0.065 ppba; and arsenic, antimony, and aluminum below the detection limit of 0.01 ppba. These data equate to the following amounts of these materials in the starting silane: boron, 0.07 ppbw; and phosphorus, 0.063 ppbw. The lifetime test on the polysilicon was over 6000 microseconds; this indicates very few, if any, heavy metal impurities. This polysilicon had a resistivity of 2000 ohm-cm, n-type. Unfortunately, no direct relationship of the reading on polysilicon versus the deposited epitaxial layer of silicon has been established. The preliminary analysis on silane from the UCC Washougal plant indicates only hydrogen and argon present in measurable quantities. UCC indicates that in steady-state equilibrium production, these gases should be stripped out.

The pricing for this type of silane has not been established yet, but it is expected to be in the range of the currently available 1000 ohm-cm or better silanes (0.50 to 2.50/g).

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## SECTION 4.0

## SILANE AND DISILANE IN JAPAN

## 4.1 MARKET SUMMARY

Until 1981, silane was used in Japan mostly for semiconductors--deposits of epitaxial silicon, silicon oxide, or silicon nitride. Most of this silane was sold as 1% to 20% mixtures with inert gases. There was only one domestic producer, Komatsu. Union Carbide Corporation and Matheson also sold U.S.produced silane in the Japanese market.

The methods of doing business in Japan are similar to those in the United States but sometimes they may seem a little more complicated. There are producers, importers, traders, distributors, resellers, and agents. Any one importer or distributor might sell through several agents or dealers. No Japanese company currently exports silane to the United States.

The Japanese government's "Sunshine Project," their photovoltaic program, has closely focused on the use of amorphous silicon solar cells. These cells are now in commercial production in Japan. This has already attracted more local producers and off-shore interest in the market.

It is estimated that the silane market in Japan in 1981 was some 8,000 kg (8 metric tons). In 1982, this grew to an estimated 13,000 kg. Komatsu had the major share of the market, which it shared with imported Union Carbide and Matheson silane. Prices seem to range from 0.20 to 0.30/g, which is comparable to U.S. prices.

## 4.2 COMMERCIAL AVAILABILITY

## 4.2.1 Manufacturers of Silane in Japan

Three companies now manufacture silane in Japan: Komatsu Electronic Metals Company, Ltd.; Mitsui Toatsu Chemicals, Inc.; and Honjo Chemicals Corporation.

Komatsu Electronic Metals Co., Ltd. 2612 Shinomiya, Hiratsuka Kanagawa Ken, 254, Japan

Komatsu has made silane for over 15 years. The industry rates it as capable of making up to 60 tons of silane, mostly for their own use in making polysilicon. Its many patents and publications (referenced in the report sections on preparation and purification) testify to its interest in the area. These publications refer chiefly to the company's preparation method of reacting magnesium silicide with ammonium chloride in liquid ammonia. Komatsu's data sheet, Appendix K, indicates that silane has a very low boron content and a minimum of other contaminants. Its deposited silicon films yield a resistivity of more than 2,000 ohm-cm. Being the only producer of silane in Japan





up to 1982, Komatsu had most of the merchant market there. One could expect that it will hold that market share as the volume expands, and very likely expand production as needed.

The Honjo Chemical Corporation 3-18-21, Nishinakajima Yodogawa-ku, Osaka 532 Japan

Honjo started production of silane in 1982, with a license from Matheson. Its capacity is estimated at three tons per year. No data were given in its response, but one could expect the product to be of the same quality as Matheson's in the United States.

Mitsui Toatsu Chemicals, Inc. 2,5 Kasumigaseki 3-chome Chiyodaku, Tokyo 100 Japan

Mitsui started up a plant capable of making five tons per year of silane early in 1983. Its process has not yet been disclosed. Product data sheets will be available later this year.

## 4.2.2 Traders or Sellers of Silane

The following companies act as wholesalers for local producers and/or import silane. They might also repackage or dilute it with other gases, as needed.

Nippon Sanso (Komatsu distributor) 16-7 Nishi-Shimbashi l-chome Minatoku, Tokyo 105 Japan Takachiho Trading (Matheson importer) 4-8 Hiroo 1-chome Shibuyaku, Tokyo 150 Japan Seitetsu Kagaku (Union Carbide importer) 22, 5-chome Kitahama Higashiku, Osaka 541 Japan Nissan Shoji Kozatokaikan Nishishinbashi, Minatoku Tokyo, 105, Japan Tomoe Shokai 1-25 Minimikamata 1-chome Otaku, Tokyo

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Suzuki Shokan 1, Kojimachi 3-chome Chiyodaku, Tokyo 100 Japan

Toyoko Kagaku 1280 Nakamaruko Nakaharaku, Kawasakishi Kanagawaken, 211 Japan

## 4.3 DISILANE

There is no commercial production of disilane in Japan, as of the end of 1982. Several companies are in the pilot-plant stage; these include Shin Etsu, Mitsui Toatsu, and possibly Honjo. Only small amounts of disilane are imported. Prices of the imported disilane are in the \$100/g range. Mitsui indicated it would have small quantities of disilane available in 1984, at prices (in Japan) of \$5/g or less. Purity data are not available.

## 4.4 COMMENTS

The announcement in June 1983 of the sale of the Matheson Gas Products operation to a joint venture formed by the Amerigas subsidiary of the UGI Corporation and Nippon Sanso K. K. of Tokyo, is expected to have an impact on the Japanese silane situation. Nippon Sanso could easily now use the Matheson technology to make silanes in Japan. Nippon Sanso has been repackaging Komatsu silane and selling it through at least six dealers.

On August 8, 1983, Air Products and Chemicals announced that they had acquired a minority interest in Daido Oxygen Co. Air Products also signed a technology exchange with this Japanese industrial gas concern. This move could have an impact on the silane industry in Japan.

## 4.5 BIBLIOGRAPHY

Dr. K. Isogaya, Mitsui Toatsu Chemicals, Inc., private communication.

Japan Economic News, 1982 issues.

Dr. M. Kobayashi, Honjo Chemical Company, private communication.



## SECTION 5.0

#### **CONCLUSIONS**

Silane has been available over the past 20 years in quality and quantities tailored to meet the requirements of the semiconductor industry, which consumed some 40,000 kg in 1982. This market will continue to grow at 12%-18%/yr. The advent of large-scale integrated circuits stimulated the search for better quality materials, including silane. So, to meet this demand, higher purity silanes have become available in the past few years.

Production capacity for silane has generally kept pace with need. In 1983, silane capacity in the United States was over 55,000 kg (50 tons). In addition, a new Union Carbide polysilicon plant started in 1983 has the capacity to make 120,000 kg/yr of silane. In Japan, the 13,000-kg silane market is supplied by three domestic producers along with imported material from four U.S. and European firms. Therefore, current and planned capacity will be adequate to serve new and existing markets.

## 5.1 SILANE

Seven U.S. producers of silane each offer two or more grades. The original epitaxial-grade silane had a deposited silicon film of 50-150 ohm-cm. New special grades have epitaxial films of 500 to a reported 10,000 ohm-cm. Most U.S. silane is made from chlorosilanes and alkali metal hydride; therefore, chlorosilane, HCl, siloxanes, carbon oxides, and hydrocarbons are common impurities. The electronic grades sell for \$0.17/g, and Premium grades cost \$0.50 to \$2.00/g in large volumes. New process work under way at several firms could result in further improvements in quality and cost. For example, silane from the new Union Carbide process contained only parts-per-billion impurities, according to the firm's analyses.

## 5.2 DISILANE

Disilane, available only in research quantities from three U.S. producers, is made from the processes described in this report, which yield mixed higher silanes and chloride contaminants. Purification, however, is not easy. The advantages of using disilane are known, but its quality, uniformity, and price must improve to make it suitable for wider use. Recently, several companies have revealed that new production processes are being developed. These could involve making disilane by passing silane through an electrical discharge, a method that should yield a much purer disilane.

Disilane prices have ranged from \$45 to \$85/g in 100-g cylinders. One company indicates that its new process could result in a higher purity disilane at \$20/g in 1984. The impact of larger disilane markets on future prices is very hard to predict at this time.

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## 5.3 JAPAN

In Japan, silane for both semiconductor and solar cell uses has been supplied by Komatsu and by imported material from three off-shore firms. Prices and quality have been similar to those in the United States. As silane is used more and more in the production of amorphous solar cells, two additional Japaneses firms have now begun producing it. Moreover, two U.S. companies that make silane have recently joined forces with Japanese partners. This all suggests that much more competitive marketing will occur in the future.

Three Japanese firms are now developing processes in order to enter the disilane market. One company said that they expect to be able to sell their disilane in Japan for less than \$5.00/g. No quality data are available, however. No silanes are currently being exported from Japan, but one company has indicated that it is surveying possible U.S. markets.

## 5.4 GENERAL COMMENTS

At the beginning of this study, we hoped that a simple, single-step purification procedure for silane might be uncovered. Unfortunately, there does not seem to be such a process. Procedures do exist, however, for removing one or two contaminants from silane in one step. All current producers of silane advise customers not to attempt to purify it, and we concur with this suggestion.

With the projected availability of new grades of silane and the new Union Carbide process for silane, the solar industry will have materials to evaluate that are more pure than previous ones. One aspect yet to be accomplished is the development of a solar specification for silane and disilane. In order to specify limits for boron, phosphorus, and heavy metals, analytical procedures will have to be developed.

Improved silanes are now coming into the market, and increased competition is expected to keep prices at fair values.

#### APPENDIX A

#### TYPICAL PROCESS SILANE COMPOSITION

Monosilane: 97%-98%. Hydrogen, chlorosilanes, silicon tetrachloride: 1.5%-2.5%. Higher silanes, arsine, phosphine, diborane: 0.5%.

(1% equals 10,000 ppm.)

The source of this analysis is Tarancon, U.S. Patent 4 099 936, July 11, 1978. This is believed to be the lithium-chlorosilane process, the most popular silane process in the United States.

Note: The material contained in these appendices is presented for information only; none of it represents endorsement of a particular product or process by the author, the Solar Energy Research Institute, or the U.S. Dept. of Energy.

## APPENDIX B

## IMPURITIES IN METALLURGICAL-GRADE SILICON

For 98% silicone-grade silicon:

Element	Maximum %	ррш
A1	0.20	2000
Fe	0.60	6000
Ca	0.10	1000
Mn	0.06	600
Cr	0.03	300
As	0.005	50
В	0.005	50
Bi	0.005	50
С	0.05	500
СЪ	0.05	500
Со	0.01	100
Cu	0.01	100
Мо	0.01	100
Ni	0.01	100
P	0.01	100
РЪ	0.003	30
S	0.01	100
ЅЪ	0.005	50
Sn	0.005	50
Та	0.01	100
Ti	0.04	400
W	0.01	100
V	0.02	200
Zn	0.005	50
Zr	0.02	200

The source of this table is the Elkem Metals Company data sheet, 1982. Silicon is produced from North Carolina quarzite, low ash coal, petroleum coke, and wood chips in an electric furnace with carbon electrodes.

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## APPENDIX C

## SILICON TETRACHLORIDE SOURCES AND POSSIBLE IMPURITIES

## Production Methods

- A. Direct production. Fumed silica producers, usually captive use: DeGussa, Cabot.
- B. Zirconium producers: Teledyne, Western Zirconium.
- C. Trichlorosilane producers: Union Carbide, Dow Corning, Texas Instruments, General Electric.
- D. Effluent from the TCS/polysilicon plants: Monsanto, Motorola, Texas Instruments, General Electric.
- E. Direct merchant producer: Van de Mark.

## Possible Impurities

- A. All metal chlorides of elements found in metallurgical-grade silicon.
- B. All metal chlorides of elements in zirconium ores.
- C. Variable--could be B, P, As, in ppb levels; C in ppm; and S in ppm. If shipped in drums, Fe and higher levels of the above elements could be present.
- D. B in ppm, P, As in ppm, C in ppm, and higher chlorosilanes (polymers).
- E. Distilled product--ppm of all elements in A.

Note: Specially distilled and purified silicon tetrachloride is available for epitaxial use at \$2 to \$4 per pound.

## APPENDIX D

#### PROPOSED SEMI STANDARDS FOR SILANE\*

# SEMI Standard C3.STD.9 for Silane Specification (SiB<sub>4</sub>) for Polysilicon and/or Silicon Dioxide Application (Proposed)

Purity: 98.8897%	
Resistivity: >50 ohm-cm n-type	
Impurities	Maximum Acceptable Level (ppm)
0xygen (0 <sub>2</sub> )	10
Water $(H_2\tilde{0})$	3
Hydrogen <sup>(H<sub>2</sub>)</sup>	10,000
Total of carbon dioxide + carbon monoxide	
$(CO_2 + CO)$	10
Total <sup>4</sup> hydrocarbons expressed as methane	40
Chlorosilane (ionizable chlorides including	
HC1 reported as C1)	1,000
Rare	40
Heavy metals	а
Particulates	a
TOTAL IMPURITIES	11,103

<sup>a</sup>To be determined between supplier and user.

Note: Percent purity may include trace quantities of nitrogen.

Notice: SEMI makes no warranties or representations as to the suitability of the standards set forth herein for any particular application. The determination of the suitability of the standard is solely the responsibility of the user. Users are cautioned to refer to manufacturer's instructions, product labels, product data sheets, and other relevant literature respecting any materials mentioned herein. These standards are subject to change without notice.

<sup>\*</sup>Adapted from the Semiconductor Equipment and Materials Institute (SEMI) specifications, August 1981.

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SEMI Standard C3.STD.10 for Silane Specification (SiH<sub>4</sub>) for Silicon Nitride Application (Proposed)

Purity: 99.9417%	
Resistivity: >50 ohm-cm n-type	
Impurities	Maximum Acceptable Level (ppm)
0xygen (0 <sub>2</sub> )	10
Water $(H_2\bar{0})$	3
Hydrogen (H <sub>2</sub> )	500
Total of carbon dioxide + carbon monoxide	
$(C0_2 + C0)$	10
Total hydrocarbons expressed as methane	10
Chlorosilane (ionizable chlorides including	
HCl reported as Cl	10
Rare	40
Heavy metals	а
Particulates	a
TOTAL IMPURITIES	583

<sup>a</sup>To be determined between supplier and user.

Note: Percent purity may include trace quantities of nitrogen.

Notice: SEMI makes no warranties or representations as to the suitability of the standards set forth herein for any particular application. The determination of the suitability of the standard is solely the responsibility of the user. Users are cautioned to refer to manufacturer's instructions, product labels, product data sheets, and other relevant literature respecting any materials mentioned herein. These standards are subject to change without notice.

Assay: Dopants:	99.59% minimum by weightAcceptor0.3 pDonor1.5 p	t pba pba
Resistivity:	>100 ohm-cm (n-type) >1000 ohm-cm (p-type)	
Trichlorosilanes:	0.4% (liquid phase) <100 ppm (liquid phase	

SEMI Standard C3.STD.11 for Silicon Tetrachloride Specification (SiCl<sub>4</sub>) (Proposed)

Notice: SEMI makes no warranties or representations as to the suitability of the standards set forth herein for any particular application. The determination of the suitability of the standard is solely the responsibility of the user. Users are cautioned to refer to manufacturer's instructions, product labels, product data sheets, and other relevant literature respecting any materials mentioned herein. These standards are subject to change without notice.

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SEMI Standard C3.STD.10 for Silane Specification (SiH<sub>4</sub>) for Silicon Nitride Application (Proposed)

Purity: 99.9417%	
Resistivity: >50 ohm-cm n-type	
Impurities	Maximum Acceptable Level (ppm)
$0xygen (0_2)$	10
Water $(H_2\tilde{O})$	3
Hydrogen (H <sub>2</sub> )	500
Total of carbon dioxide + carbon monoxide	
$(C0_{2} + C0)$	10
Total <sup>'</sup> hydrocarbons expressed as methane	10
Chlorosilane (ionizable chlorides including	
HCl reported as Cl)	10
Rare	40
Heavy metals	а
Particulates	а
TOTAL IMPURITIES	583

<sup>a</sup>To be determined between supplier and user.

Note: Percent purity may include trace quantities of nitrogen.

Notice: SEMI makes no warranties or representations as to the suitability of the standards set forth herein for any particular application. The determination of the suitability of the standard is solely the responsibility of the user. Users are cautioned to refer to manufacturer's instructions, product labels, product data sheets, and other relevant literature respecting any materials mentioned herein. These standards are subject to change without notice. •

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## APPENDIX E

	SiH <sub>4</sub>	Si <sub>2</sub> H <sub>6</sub>	Si 3 <sup>H</sup> 8	Si <sub>4</sub> H <sub>10</sub>
Melting point ( <sup>O</sup> C)	-185	-132.5	-117.4	-84.3
Boiling point ( <sup>O</sup> C)	-111.9	-14.5	52.9	107.4
Vapor pressure 0 <sup>O</sup> C -118 <sup>O</sup> C	53	 1	95 	9 <b>.</b> 1
Critical temp. ( <sup>O</sup> C)	-3.5	109	189	249
Density of liquid at l atm g/mL	0.68	0.69	0.725	0.79

## PHYSICAL PROPERTIES OF SILANES

Data from he Chemistry of Silicon, Rochow [39].

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## APPENDIX F

## DATA ON UNION CARBIDE MOLECULAR SIEVES

UNION CARBIDE CORPORATION LINDE DIVISION National Specialty Gases Office Department HGR 100 Davidson Avenue-Box 444 Somerset, N.J. 08873



## **Molecular Sieves**

The first commercial quantities of UNION CARBIDE Molecular Sieves became available in 1954 – the result of Union Carbide's research with natural zeolites which began in 1948.

UNION CARBIDE Molecular Sieves are synthetically produced, crystalline metal alumino-silicates, that have been activated for adsorption by removing their water of hydration. Since little or no change of structure occurs during this dehydration, unusual, highly porous adsorbents are formed that have a strong affinity for water and certain other gases and liquids.

Unlike other adsorbents, Molecular Sieves have a precise, uniform size and molecular dimension. According to the size of these pores, molecules may be readily adsorbed, slowly adsorbed or completely excluded.

This sieve-like selectivity, based on molecular size, plus a selective preference for polar or polarizable molecules, gives Molecular Sieves an extremely high level of adsorption efficiency, and permits close tailoring of the adsorbent to the specific use. Molecular Sieves have a basic formula of  $M_{\rm e}/_{\rm n}$   $O\cdot Al_2O_3\cdot \times SiO_2\cdot yH_2O$  where M is a cation of n valence. They are completely different from the gel-type amorphous alumino-silicates commonly referred to as zeolites, which although similar in composition, do not exhibit any selectivity based on molecular size.

Through its pioneer synthesis techniques in adsorption technology, Union Carbide has been able to produce and evaluate numerous types of synthetic zeolites, differing in chemical composition, crystal structure and adsorption properties.

UNION CARBIDE Molecular Sieves are produced in a wider range and type than any other adsorbents. They are available in the form of powder, beads or pellets. Among those which have been found to be more commercially useful are Type 4A and Type 13X which have the following unit cell formulas:

Type  $4A - Na_{12} [(AIO_2)_{12}(SiO_2)_{12}] \cdot 27H_2O$ Type  $13X - Na_{86} [(AIO_2)_{86}(SiO_2)_{106}] \cdot 276H_2O$ 

In both cases the sodium ion can be exchanged to form other useful products.

This catalog lists UNION CARBIDE Molecular Sieves that have the widest range of commercial use. Technical and application information for each of these is available upon request. Many less commonly used sieves for specialized applications, although not listed, are also available. Inquiries should be sent to the Union Carbide Specialty Gases Office listed on the back cover.



# Adsorbents • Molecular Sieves

	Part Number	Quantity	Description	Price
	MS-1001	<sup>1</sup> 4 в	Powder	\$ 11 00
	MS-1002	1/2 lb - Case of 6	Powder	56.00
Molecular Sieves	MS-1002	2 lb - Case 010	Rewder	20.00
Earmy Douglas and college	MS-1004	2 lb - Case of 4	Powder	68.00
Form: Powder and pellets	MS-1004	2 10 - Case 01 4	Bourder	75.00
Nominal Pore Diameter: 3Å	MS-1005	30 lb	Powder	142 00
	1000	3010	FOWDER	142 00
Molecules Excluded: >3A	MS.1014	1.15	1/ in Delland	12.00
effective diameter,	MS-1014	1 lb Care of 6	/16 In Pellets	13.00 66.00
e.g., ethane	MS-1015	5 lb	16-In: Pellets	28.00
Base: Alumina-Silicate	MS-1017	5 lb Care of 4	16-III. Pellets	121.00
	MS 1019	25 lb		121.00
Cation. Potassium	MS 1018	25 lb Case of 4	/16 In Pellets	133 00
	MS-1019		/16-In Pellets	412.00
Heat of Adsorption (max.):	WI3-1020	5010	/16-In. Pellets	202.00
	MS-1028	1 lb	1/8 in. Pellets	13.00
Application:	MS-1029	1 lb - Case of 6	1/8 in. Pellets	66.00
The preferred Molecular Sieve	MS-1030	5 lb	%-in. Pellets	38 00
adsorbent for the commercial	MS-1031	5 lb - Case of 4	% in. Pellets	121.00
dehydration of unsaturated	MS-1032	25 lb	1/8 in Pellets	135.00
hydrocarbon streams such as	MS-1033	25 lb Case of 4	1/a in Pellets	412.00
cracked gas, propylene, butadiene and acetylene. It is also used for drying polar liquids such as	MS 1034	50 ю	¹∕ <sub>8</sub> .in Pellets	202 00
Type 4A	MS-1069	1/2 Шо	Powder	\$ 11 00
	MS-1070	1/2 lb - Case of 6	Powder	56 00
Molecular Sleves	MS-1071	2 16	Powder	20 00
Form: Powder pellets mesh and beads	MS-1072	2 lb – Case of 4	Powder	68 00
	MS-1073	12 lb	Powder	75 00
Nominal Pore Diameter: 4Å	MS-1074	30 lb	Powder	142 00
Molecules Excluded: >4Å	MS-1082	1.16		13.00
effective diameter, e.g., propane	MS-1083	1 lb Case of 6	1/16 in Pellets	66.00
	MS-1084	5.16	Vusin Pellets	38.00
Base: Alumina-Silicate	MS-1085	5 lb - Case of 4		121.00
Cation: Cation	MS-1086	25 lb		135.00
Cation: Sodium	MS-1087	25 lb - Case of 4		412.00
Heat of Advantion (max )	MG-1087	20 ID - Case 01 4	1/ in Pollets	412 00
1800 Btu/ib H <sub>2</sub> O		3010	716 - III. Pellets	
Application	MS-1096	1 lb	1/8 -in. Pellets	13 00
The preferred Molecular Sieve adsorbent	MS-1097	1 lb - Case of 6	% in Pellets	66 00
for static dehydration in a closed gas or	MS-1098	5 lb	%-in. Pellets	38 00
liquid system. It is used as a static	MS-1C99	5 lb - Case of 4	%-in. Pellets	121 00
desiccant in household refrigeration	MS-1 100	25 lb	%-in. Pellets	135 00
systems, in packaging of drugs, in	MS-1101	25 lb Case of 4	1/8 in. Pellets	412 00
electronic components, in perishable chemicals and as a water scavenger	MS-1102	50 lb	<sup>9</sup> 8-in. Pellets	202 00
in paint and plastic systems.	MS-1110	1.16	14 x 30 Mesh	\$ 13 00
Also used commercially in drying	MS-1111	1 lb ~ Case of 6	14 X 30 Mesh	- 66 00
saturated hydrocarbon streams.	MS-1112	5 lb	14 X 30 Mesh	38 00
Molecular Sieves with Indicator are	MS-1113	51b - Case of A	14 X 30 Mesh	121 00
beads that have been chemically	MS.1114	25 lb	14 X 30 Mech	135.00
impregnated to display a blue color	NIS-1114		14 × 30 Mesh	112 00
when fully activated by removing	MIS-1115	2 310 - Case 014		412 00
the water of hydration. When a gas	MS-1116	50 ID	14 × 30 Mesh	202 00

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	Part Number	Quantity	Description	Price
Type 44 (Continued)				
	MS-1124	1.15	8 X 12 Beads	<b>S</b> 13 00
	MS.1125	1 lb - Care of 6	8 x 12 Beads	66.00
Molecular Sieves	MS 1125	5 lb	8 x 12 Beads	38.00
	MS 1127	5 lb - Care of 4	9 × 12 Boods	121.00
stream is dried using this product, the	MC 1 120		9 X 12 Deads	135.00
Drue color will turn to pink as water is	MS 1120	25 Ib 25 Ib Case of 4	0 × 12 Beads	412.00
signe. The signe may then be read	1013-1129	25 ID - Case of 4	8 X 12 Beads	102.00
tivated at 200°C under vacuum or		50 16		
nitrogen atmosphere for several hours	MS-1138	t lb	4 × 8 Beads	13 00
More conveniently, the sieve may be	MS-1139	1 lb – Case of 6	4 × 8 Beads	66 00
120 of this patelog for a low page	MS-1 140	5 lb	4 × 8 Beads	38.00
molecular sieve das purifier column	MS-1141	5 lb – Case of 4	4 × 8 Beads	121 00
that may be used with this product or	MS-1142	25 lb	4 × 8 Beads	135.00
any of the other molecular Sieve types.	MS-1143	25 /b Case of 4	4 × 8 Beads	412.00
	MS-1144	501b	4 × 8 Beads	202 00
	MS-1152	1 Ib	8 × 12 Beads w/Indicator	20 00
	MS-1153	1 lb - Case of 6	8 × 12 Beads w/Indicator	105.00
	MS-1154	5 lb	B x 12 Beads w/indicator	70 00
	MS-1155	5 lb - Case of 4	8 × 12 Beadsw/Indicator	243 00
	MS-1156	25 lb	8 × 12 Beads w/Indicator	290.00
	•			
Type 5A				
UNION CARBIDE	MS-1179	1/2 Ib	Powder	\$ 11 00
Molecular Sieves	MS-1180	1/2 Ib Case of 6	Powder	56.00
Noiecular Sieves	MS 1181	2 lb	Powder	20 00
Form: Powder and pellets	MS-1182	2 lb Case of 4	Powder	68 00
	MS-1183	12 Ib	Powder	75 00
Nominal Pore Diameter: 5Å	MS 1184	30 lb	Powder	142 00
Molecules Excluded: >5Å	MS-1192	116	1. in Pellets	:3 00
effective diameter,	MS-1193	1 lb Case of 6	Vis in Pellets	65.00
e.g., iso compounds and	MS 1194	5 lb	Vie in Peliets	38.00
all four carbon rings	MS-1195	5 lb ··· Case of 4	Via in Pellets	121 00
Received Allowing Ciliante	MS-1196	25 lb	1/14 int Pellets	135 00
Base: Alumina-Silicate	MS-1197	25 lb Case of 4	Vicin Pellets	412.00
Cation: Calcium	MS-1198	50 lb	1/16 in Pellets	202 00
Heat of Adsorption (max.):	MS-1206	1 lb	% in. Pellets	:3.00
1800 Btu/Ib H <sub>2</sub> O	MS-1207	1 lb - Case of 6	Win Pellets	65.00
	MS-1208	5.16		39.00
Application:	MS-1209	5 lb = Case of 4	Varin Pellets	121.00
Separates normal paraffins	MS.1210	25 lb	V_ in Pellets	121.00
from branched-chain and	MS.1211	25 lb Care of 4	Varia Pellets	112.00
a selective adsorption process.	MS-1212	50 lb	V <sub>8</sub> −in. Pellets	202.00
 <b>T A</b> 11/200			1/	
Type AW-300	MS-1042	1 Ib	/16 in Pellets	13 00
UNION CARBIDE	MS-1043	1 lb – Case of 6	16 in Pellets	66.00
Molecular Sieves	MS-1044	5 lb	16 in Pellets	38.00
MUIECUIAI SIEVES	MS-1045	5 lb - Case of 4	V16 in Pellets	121 00
Form: Pellets	MS-1046	25 lb	16 in Pellets	1,35 00
Nominal Pore Diamotory 40	MS-1047	25 lb Case of 4	716 in Pellets	412 00
	MS-1048	50 lb	V <sub>16</sub> -in, Pellets	202 00
Molecules Excluded: 4A	MS-1056	1 њ	<sup>1</sup> / <sub>8</sub> -in Pellets	13 00
Base: Alumina-Silicate	MS-1057	1 lb Case of 6	78 in Pellets	66 00
	MS-1058	5 lb	1/8 in Pellets	38 00
Application:	MS-1059	5 lb – Case of 4	% in Pellets	121.00
Dehydration of trace acid-	MS-1060	25 lb	V <sub>8</sub> in Pellets	:35.00
containing streams and ion	MS-1061	25 lb Case of 4	8 in Petlets	412 00
exchange	MS-1062	50 lb	1/8-In Pellets	202 00

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# Adsorbents • Molecular Sieves

	Part Number	Quantity	Description	Price
	MS-1220	1 /b	1/16-in. Pellets	\$ 13 00
UNION CANDIDE	MS-1221	1 lb – Case of 6	1/16 - in. Pellets	66.00
Molecular Sieves	MS-1222	5 lb		38.00
Form: Pellets	MS-1223	5 lb – Case of 4	1/16 - in. Pellets	121 00
	MS-1224	25 lb	1/16 in Pellets	135 00
Nominal Pore Diameter: 5Å	MS-1225	25 lb - Case of 4	1/16 - in. Pellets	412 00
	MS-1226	50 Ib	Visin. Pellets	202 00
Molecules Excluded: >5A		· ·		
effective diameter	MS-1233	1 њ	1/8-in. Pellets	13 00
Para: Alumina Silicata	MS-1234	1 lb - Case of 6	%-in. Pellets	66 00
Base. Aldinina-Sincate	MS-1235	5 lb	1/8-in. Pellets	38 00
	MS-1236	5 lb - Case of 4	1/8 in. Pellets	121 00
	MS-1237	25 lb	%-in. Pellets	135.00
Application:	MS-1238	25 lb Case of 4	1/8-in. Pellets	412 00
Dehydration of trace acid- containing streams and ion exchange.	MS-1239	50 lb	<sup>1</sup> / <sub>8</sub> -in. Pellets	202 00
Туре 13Х				
UNION CARBIDE	MS-1328	У <sub>2</sub> ю	Powder	\$ 11 00
Molecular Sieves	MS-1329	Y₂ lb − Case of 6	Powder	60 00
WOIECUIAI SIEVES	MS-1330	2 lb	Powder	21 00
Form: Powder, pellets and beads	MS-1331	2 lb Case of 4	Powder	71 00
	MS-1332	12 Ib	Powder	80 00
Nominal Pore Diameter: 10 Å	MS-1333	30 њ	Powder	152 00
Molecules Excluded > 10 Å	MC 1241	•	1/	11.00
effective diameter,	NIG-1341		/16-In Pellets	14 00
e.g., (C4F9)3N	NIG-1342		16-In Pellets	11 00
	MS 1244	5 lb Care of 4	1/in Pollets	40 00
Base: Alumina-Silicate	MS 1344	25 15	1/ in Dellers	133.00
	MS 1345		16 In Pellets	145 00
Cation: Sodium	MG 1247	25 ID - Case 01 4		440 00
Application	110 1047	3010	/16-III. Penets	217 00
Used commercially for general	MS.1355	1 //b	1/ in Pellets	14.00
gas drying, air plant feed	MS-1355	1 lb Case of 6	<sup>1</sup> / <sub></sub> Pellets	71 00
purification (simultaneous	MS-1357	F Ib		71 00
removal of H <sub>2</sub> O and CO <sub>2</sub> ) and	MS-1358	5 lb Core of 4	Vain Pellets	40 00
liquid hydrocarbon and	MS-1359	25 lb		145.00
natural gas sweetening	MS-1360	25 lb - Case of 4		145.00
(H <sub>2</sub> S and mercaptan removal)	MS-1361	50 lb	<sup>1</sup> / <sub>8</sub> -in. Pellets	217.00
	MS-1362	1 lb	4 × 8 Beads	\$ 14.00
	MS-1363	1 lb Case of 6	4 × 8 Beads	71.00
	MS-1364	5 lb	4 × 8 Beads	40.00
	MS-1365	5 lb Case of 4	4 x 8 Beads	133.00
	MS-1366	25 lb	4 × 8 Beads	145.00
	MS-1367	25 lb Case of 4	4 × 8 Beads	440.00
	MS-1368	50 lb	4 X 8 Beads	217.00
	MS-1369	1 lb	8 × 12 Beads	14 00
	MS-1370	1 lb ~ Case of 6	B × 12 Beads	71 00
	MS-1371	5 lb	8 × 12 Beads	40 00
	MS-1372	5 lb - Case of 4	8 × 12 Beads	133 00
	MS-1373	25 lb	8 × 12 Beads	145 00
	MS-1374	25 lb - Case of 4	8 × 12 Beads	440 00
	MS-1375	50 lb	8 × 12 Beads	217 00



## APPENDIX G

## LIST OF U.S. COMPANIES CONTACTED

#### **Producers and Sellers:**

Airco Industrial Gases 575 Mountain Avenue Murray Hill, NJ 07974 (201) 464-8100 Air Products and Chemicals, Inc. P. 0. Box 1104 Allentown, PA 18105 (215) 481-8257 Robert Welch, Product Manager Liquid Carbonic Corporation 135 S. LaSalle Street Chicago, IL 60603 Dr. W. G. Lee, National Account Manager (312) 855-2500 Chronar Corporation P. 0. Box 177 Princeton, NJ 08540 (609) 587-8000 Dr. Allen Delahoy Allied Chemical P. O. Box 1087R Morristown, NJ 07960 (201) 455-2000 J. H. F. Loozen, Manager, New Business Development Matheson Gas Products 30 Seaview Drive Secaucus, NJ 07094 Frank Sconavacca, V.P., Marketing (201) 867-4100 Scientific Gas Products, Inc. 2330 Hamilton Blvd. S. Plainfield, NJ 07080 (201) 754-7700 Synthatron Corporation 50 Intervale Road Parsippany, NJ 07054 (201) 335-5000 Paul Mann, National Sales Manager



Union Carbide Corporation Linde Specialty Gas Products P. O. Box 444 100 Davidson Avenue Somerset, NJ 08873 (201) 356-8000 Steve A. Conviser, Business Manager Pat Taylor, Product Manager

## Sellers Only:

Ideal Gas Products Inc. 977 New Durham Road Edison, NJ 08817 (201) 287-8766 H. G. Gill, Chairman

M. G. Scientific Gases
M. G. Burdett Gas Products
175 Meister Avenue
N. Branch, NJ 08876
(201) 321-9595



## APPENDIX H

NASA TECH BRIEF:

#### PURIFYING SILANE

## Eliminating Impurity Traps in the Silane Process

The extraction of a small slipstream from separators prevents impurities from building up.

The second se

NASA's Jet Propulsion Laboratory, Pasadena, California



The **Redistribution Reaction Section** of the silane process progressively separates the heavier parts of the chlorosilane feedstock until a light silane product is available for pyrolysis. The color lines indicate additions to the process that prevent impurity buildup. The redistribution reactors catalytically adjust the composition of the feed for more favorable separations.

A modification has been proposed to reduce impurity trapping in the silane process for producing semiconductorgrade silicon. A small amount of liquid containing impurities is withdrawn from the processing stages in which trapping occurs and is passed to an earlier processing stage in which such impurities tend to be removed via chemical reactions.

The silane process is one of the most promising methods for producing silicon for low-cost solar cells by converting inexpensive metallurgical-grade silicon. In the silane process, the metallurgical-grade material is first hydrogenated to produce a feed stream composed primarily of trichloroslane and silicon tetrachioride but also containing other chlorosilanes. The feedstock is passed through a series of separator columns that produce ultra-high-purity silane (SiH4). A pyroihydrogen, which is recycled to the hydrogenator, and semiconductor grade silicon.

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A problem with the silane process has been that certain impurities of intermediate volatility can become trapped in the separator loops. Eventually the impurities build up to the point where they overload the separator columns and contaminate the silane product.

In the modified process (see figure) a small stream of liquid is withdrawn from the last two separator columns and returned with recycled silicon tetrachioride to the hydrogenator. There, some impurities are converted to insoluble metal complexes that settle and are removed with the heavy-waste stream Other impurities continue to the stripper column, where they pass off with other volatile components. (The stripper column removes such gases as nitrogen and methane dissolved in the feed stream from the hydrogen sulfide ) greater than that of hydrogen sulfide )

The effluent from the stripper — primarily trichlorosilane and silicon tetrachloride essentially free of high-volatility contaminants — enters separator column 1. There, trichlorosilane and lighter components are extracted and sent as the feed to separator column 2. Silicon tetrachloride and heavier components are removed and returned to the hydrogenator.

In separator 2, dichlorosilane and lighter components are extracted and sent to separator column 3. Heavier chlorosilanes are returned to separator 1, except that in the new process a small slipstream is diverted to the recycling slicon tetrachloride. The slipstream orevents impurities with voiatility greater that of dichlorosilane bulliess than that of dichlorosilane trom becoming trapped and accumulating in the loop between separators 1 and 2. Such im purities include boron trichloride, phosphorus chloride, and arsenic chloride.

In separator 3, silane is extracted as the product. Diborane and other impurities are returned to separator 2, and a slipstream is added to the silicon tetra chloride return. The slipstream prevents such impurities as boron hydride, phosphorus hydride, and arsenic hydride

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from building up in the loop between separators 2 and 3 Very small slipstreams are sufficient A continuous bleed of only 0.01 to 0.1 percent of the column-bottom recycle

NASA's Jet Propulsion Laboratory. For further information, Circle 24 on the TSP Request Card NPO-15217

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## APPENDIX I

## NASA TECH BRIEF:

## **REMOVING IMPURITIES FROM SILANE**

## **Removing Chlorides From Metallurgical-Grade Silicon**

Process for making 'ow-cost silicon for solar cells is further improved.

NASA's Jet Propulsion Laboratory, Pasadena, California



Silane Product Recycled To Feed Stripper Column converts some of the heavy impurities to volatile ones that pass off at the top of the column with light wastes. The impurities — chlorides of arsenic, phosphorus, and boron — would otherwise be carried to subsequent distillations where they would be difficult to remove. Since only a small amount of silane is recycled, silicon production efficiency remains high.

Upgrading metallurgical-grade silicon to high-purity sensiconductor-grade silcon for low-cost solar cells requires a critical step in which chlorositanes are separated from a silicon tetrachicride can er for further processing. When the chlorosilanes are separated, such impunities as arsenic chloride, chlosphorus chloride, and boron chloride tend to stay with them. The retention of these impurities in the feedstock imposes a heavier imputify load on downstream processing edupment and makes it more difficult to maintain high punity in the silicon product.

However, a small amount of silane added to the chlorosilane and silicon tetrachioride mixture eliminates the impuri-

U.S. Patent 4,340,574 July 20, 1982

ties. A small portion of the silane produced in a later reaction is simply diverted to the feed stripper obtimm in which the chlorosilane and silicon tetrachioride are separated (see figure). The silane reacts with the chloride impunities to form hydrides, such as arsenic hydride, phosphorus hydride, and boron hydride. These volatile compounds are readily removed along with other light wastes in the column.

The silane enters at the bottom of the feed stripper column. Since silane is a volatile substance, it rises the entire length of the column. It thus has a longer time to react with impurities than if it were injected at a higher level in the column. Excess silane basses of at the top with the other light gases

Of course the inpurity concentrations in the feedstock are already ow -usually less than tipom to about 10 ppm. To ensure complete reaction, the share should be added in concentrations of 10 to 100 ppm (moles of share per invion moles effectstock). This concentration represents an insignificant ross of otoduct silane for conversion, to semconductor-grade silicon *This work was cone by William C* 

This work was cone by William C Breneman and Larry M. Coleman of Union Carbide Corp. for NASA's Jet Propulsion Laboratory. For further formation. Circle 25 on the TSP Reguest Card NPO 15218.

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#### APPENDIX J

## NASA TECH BRIEF: REMOVING IMPURITIES WITH THE CONTINUOUS-FLOW PROCESS

#### Low-Waste Purification of Silicon

A continuous-flow process converts metallurgical-grade silicon to semiconductor-grade silicon.

NASA's Jet Propulsion Laboratory, Pasadena, California



This **Purlfication Process** starts with impure (metallurgical-grade) silicon and produces high-purity silicon suitable for semiconductor applications. The input silicon is reacted with hydrogen and silicon tetrachloride to produce chlorositanes; by a combination of distillation and disproportionation in resins, the silicon is converted to silane that is pyrolyzed to pure silicon. The H<sub>2</sub> and SiCl<sub>4</sub> are recycled in the continuous-flow process.

The ultra-high-purity silicon required for solar cells. transistors, and integrated circuits can be produced from metallurgical-grade silicon by the formation and pyrolysis of silane gas (SiH<sub>4</sub>) in a continuous-flow process that maximizes product purity with a minimum amount of equipment. The integrated process recycles unreacted and byproduct materials, thus minimizing material losses and simplifying waste disposal. It also ensures the effective removal of impurities, including boron.

The metallurgical-grade silicon is reacted with H<sub>2</sub> and SiCl<sub>4</sub> in the system shown in the figure to produce chlorosilanes (H<sub>x</sub>SiCl<sub>4-x</sub>) By a combination of distillation and redistribution, the lighter (hydrogen-rich) chlorosilanes progress through the system, and the heavier (chlorine-rich) ones are fed back to distillation columns and to disproportionation or hydrochiorination reactors. The overal process consumes the silicon and produces high-purity SIH4, that is pyrolyzed to high-purity submicron particles of silicon. The H2 produced in the pyrolysis is fed back to the hydrochlorination reactor.

Metallic impurities are fluxed out of the system by periodic draining of small amounts of contaminated SICI<sub>4</sub>. Boron is specially removed by the disproportionation resins and controlled distillation The principal merit of this system is the specific sequence in which the different steps are integrated. As the figure shows, the first distillation column recycles SiCl<sub>4</sub>, the third column separates out ultra-high-purity SiH<sub>4</sub>, and the intermediate second column separates fractions that pass to resin disproportionation-reaction zones. This work was done by William C

This work was done by William C Breneman and Larry M. Coleman of Union Carbide Corp. for NASA's Jet Propulsion Laboratory. For further information, Circle 23 on the TSP Request Card NPO-15033

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#### APPENDIX K

## KOMATSU SILANE DATA SHEET

## SiH<sub>4</sub> Gas (Monosilane)\*

#### Outstanding Characteristics

Boron content: less than 0.02 ppb Resistivity of deposit: more than 500 ohm-cm.

Komatsu Monosilane Gas can not be matched by any other gases of this kind in its high purity, high resistivity, uniformity and reliability. Komatsu's proprietary process and the biggest production in the world naturally give such properties to the monosilane gas.

Resistivity of deposited film will be 2,000 ohm-cm minimum, as all gas-producing systems are well controlled. Due to its high purity and no halides contained, Komatsu monosilane gas is ideal for epitaxial growth, thin film deposition and formation of perfect layer of silicon oxide and silicon nitride.

Komatsu monosilane gas is usually supplied in undiluted condition in an appropriate iron cylinder. The cylinder standard capacity is approximately 10 or 40 litre water content. The gas pressure is approx. 72 kg/cm<sup>2</sup>-1,000 pounds per square inch. In this case, the gas weight is approximately 1 kg in a 10 litre cylinder. Diluted gas with high purity diluents such as hydrogen, nitrogen or argon will be available upon request.

## General Properties

Monosilane is a colorless and orderless gas at room temperature, and is spontaneously flammable in air and other oxidizing gases, and reacts violently with free halogen or heavy metal hydrides. It will decompose into silicon and hydrogen by heating higher than  $300^{\circ}$ C, and by an electric discharge.

Physical constants are as follows.

Molecular weight:	32.12
Boiling point:	$-112^{\circ}C$ (-169.6°F)
Freezing point:	-185 <sup>°</sup> C (-301 <sup>°</sup> F)
Critical temperature:	$-4^{\circ}C$ (24.8°F)
Critical pressure:	48 atm
Specific volume at 70°F,	l atm. 12.049 cf/1b.
Heat of formation:	7 <b>.</b> 2 Kcal/mol
Densitygas at 20 <sup>0</sup> C:	1.44 g/L

\*Adapted from data sheet No. 105 issued by Komatsu Electronic Metals Co., Ltd., Tokyo, Japan.

## APPENDIX L

## SILANE DATA SHEETS

## I. Airco Industrial Gases

Silane SiH4			
	Product Description Silane is available in the pure form or as are available:	from Airco Spec a gas mixture. Th	ialty Gases nree grades
	Electronic Grade V.L.S.I. Grade		high ourity
	of the charge coupled nitration.	cifically to meet the device and high	purity purity
	Specifications		
	Purity — Electronic Grade		
		Maximum	Typical
	0	Impurities	Analysis
	Chlorosilanes	1000 ppm -	< 100 ppm
	Carbon Monoxide +		
	Carbon Dioxide	20 ppm -	< 5 ppm
	Hydrogen	5000 ppm ·	<1000 ppm
	Methane	50 ppm -	< 30 ppm
	Typical Hesistivity	>100 ohm/cm	
	Purity — V.L.S.I. Grade*		
		Maximum	Typical
	Oxygen	10 ppm	< 1 ppm
	Chlorosilanes	100 ppm -	< 100 ppm
	Carbon Monoxide + Carbon Dioxide	5 nnm 🚽	< 5 nnm
	Moisture	3 ppm	< 1 ppm
	Hydrogen	1000 ppm	< 500 ppm
	Typical Resistivity	>100 ohm/cm	S ppm
	Purity — C.C.D. or Nitride Grade* Maximum Impurities		
	Oxygen	1 ppm	
	Nitrogen	25 ppm	
	Carbon Monoxide +	i ppm	
	Carbon Dioxide	2 ppm	
	Argon	1 ppm 1 ppm	
	Hydrogen	200 ppm	
	Methane	1 ppm	
AIRCO	ypical Hesistivity	~2500 onm/cm	
	'Available in Airco Spectra Seal≋	aluminum cylinders only	(over)
AIG 1158-8 5-83			,

## I. Airco Industrial Gases (Concluded)

#### **General Information**

C.C.D. or Nitride grade silane has been developed to meet the more stringent demands for carrier lifetime and mobility of charge coupled semiconductor devices. It is capable of growing epitaxial silicon with a resistivity in excess of 2500 ohm/cm.

Cylinders to be used with silane or silane mixtures are treated individually from the start. They are specially prepared by the manufacturer before shipment to Airco, where they undergo an extensive cleaning and passivation sequence. Once this has been completed the cylinders are filled and then remain only in silane service.

#### **Special Note**

In order to meet the high purity requirements of this material, specially treated aluminum cylinders (Spectra Seal®) must be used. When provided in Airco's Spectra Seal cylinder, gas specifications listed will not change with time or temperature through at least 90% of product usage. Shelf life is guaranteed to be at least one year.

#### **Product Handling**

To help us maintain these levels of purity, please read our data sheet — "Procedures for the storage and handling of electronic gases." Cylinder Sizes—

Electronic grade silane is available in steel cylinders containing 15,000 gm, 10,000 gm or 500 gm. Mixtures are available in #200 and #80 size cylinders.

V.L.S.I. grade is available in a size #150A Spectra Seal aluminum cylinder containing 5,000 grams of material. V.L.S.I. mixtures are available in #150A and #30A size Spectra Seal aluminum cylinders.

C.C.D. or Nitride grade is only available in Spectra Seal aluminum cylinders containing 5,000 gm, 2,500 gm, 1,000 gm or 500 gm. Mixtures are available in #150A and #30A size Spectra Seal aluminum cylinders.

Cylinder Valve Outlets-

For all silane and silane mixture cylinders: CGA #350.

Handling Equipment-

Regulator Model -

Stainless Steel Model #52-75 (350) Flowmeter Model —

Stainless Steel Model S75\*

"A number of standard ranges are available
#### II. Air Products and Chemicals, Inc.



SPECIALTY GAS DEPT. AIR PRODUCTS AND CHEMICALS, INC. BOX 538 ALLENTOWN, PA 18105-0538

NOTE: Refer to enclosed Price List for current pricing information

#### II. Air Products and Chemicals, Inc. (Continued)

#### Silane (Continued)

Semiconductor Grade > 100 ohm-cm							
ORDERIN Cylinder Size	G INFORMATION COMMONITY CODE	CYLINDER DIMENSIONS 10 (cm)	CONTENTS Ids (g)	GROSS WEIGHT Ibs (kgs)	RECOMMEND	ED EQUIPMENT DELIVERY PRESSURE RANGE psig (kPa)	PAGE NO.
A A A D-1	A01-8-4650510000 A01-F-465055000 A01-3-465055000 A01-3-465051000 A01-L-465051000 A04-J-46505	9 x 55 (23 x 140) 9 x 55 (23 x 140) 6 x 19 (15 x 48)	22 (10.000) 11 (5.000) 7 (3.000) 2 (1.000) 0.2 (100)	162 (73) 151 (68) 147 (67) 142 (64) 12 (5)	<b>Two-Stage F</b> E12-6-C445A E12-W-C445B E12-C-C445D E12-U-C445F	leguiators 0-25 (0-172) 0-50 (0-345) 0-100 (0-690) 0-250 (0-1,724)	108 108 108 108

ADDITIONAL DATA

For silane mixtures and other gases used by the semiconductor industry turn to page 86.

# Silicon Tetrachloride (SiCl<sub>4</sub>)

Toxicily—Toxic Extremely irritating and destructive to tissues: contact with skin causes severe burns. Compatible Materials—Highly corresive when moist. Preferred materials of construction are stainless steel (type 304 or 316). Tetion, Pyrex\* or quartz. Molecular Weight -169 9 Cylinder Pressure at 70°F (21.1°C) -0 psig (0 kPa) Liquid Density at 60°F (15°C) -92 8 lb ftr (1.486 5 kg/m<sup>2</sup>)

#### A toxic, coloriess, nonflammable liquid with a detectable odor. Reacts violently with water to form hydrogen chloride

Cylinder Color-Silver

Cylinder Valve Oullet—3 8" compression fitting DOT Hazard Class—Corrosive Material DOT Label—Corrosive

Semi	conductor	Grade					
ORDERIN Cylindea Size		CYLINDER DIMENSIONS	CONTENTS Ibs (kgs)	GROSS WEIGHT Ibs (kgs)	RECOMMENI Commodity Code	DED EQUIPMENT DELIVERY PRESSURE RANGE paig (kPa)	PAGE NO
5 gal	A51-K-46805	12 x 19 (30 x 48)	55 (25.0)	80 (36)	None Requi	red quid under	
		ADD For c indus	ITIONAL DATA other gases used by the stry turn to page 86.	e semiconductor	normal cond	itions.	

F.O.B. Hometown, PA

Pyrex\* is a registered trademark of Corning Glass Works.

A Air Products



#### II. Air Products and Chemicals, Inc. (Continued)



# Specialty Gas Data Sheet

#### SILANE

SILANE/SILICON TETRAHYDRIDE (SIH4) SPECIFICATIONS Resistivity > 100 ohm-cm A sample of each batch of epi grade silane is evaluated on our own reactor. Silane is deposited on silicon substrates and then the resistivity of the undoped layers is measured. PHYSICAL PROPERTIES silicon and flammable hydrogen (SiH₄→Si + 2H₂). It is also decom-32.12 Molecular weight posed by an electric discharge. Keep the product away from heat, Boiling point at 1 atm -170°F (-112°C) sparks, and open flame. Color Colorless 45.6 lb/ft3 (730.4 kg/m3) Critical density Toxicity Critical pressure 702.5 psia The American Conference of 25.7°F (-3.5°C) Critical temperature Governmental Industrial Hygienists 0.0826 lb/ft3 (1.32 kg/m3) Density, Gas at 1 atm 32°F (0°C) has recommended a threshold limit of 0.5 ppm for silane. Flammable limits in air Pyrophoric, spontaneously The toxicological properties flammable have not been fully investigated. Melting point at 1 atm -301°F (-185°C) If inhaled, it may be Irritating Specific gravity at -301°F (-185°C) to the respiratory tract and may (Air = 1)0.68 cause headache and nausea. Use only with adequate ventila-tion. If silane is inhaled, Specific volume at 1 atm 70°F (21.1°C) 12.1 ft3/lb (0.755 m3/kg) remove the victim to fresh air Vapor pressure at -220.9°F and keep him warm and quiet. 1.9 psia (-140.5°C) If respiration has stopped, start Viscosity at 1 atm 59°F (15°C) 112.4 micropoise mouth-to-mouth artificial respiration at once. Seek medical assistance promptly. SAFETY CONSIDERATIONS TYPICAL APPLICATION CAUTION Silane is used as a source of Flammability **GENERAL HANDLING** high purity silicon for epitaxial and thin film deposits, and INFORMATION EXTREMELY FLAMMABLE. DO NOT EXPOSE TO THE ATMOSPHERE for low temperature vapor Silane should be stored and deposition of silicon oxide and handled in well-ventilated The major hazards of silane silicon nitride. areas at positive pressures. are associated with its pyrophoric Isolate from halogens, oxygen and combustible, organic, or properties. Silane is spontaneously flammable upon contact oxidizing materials. Avoid conwith air or with oxidizing gases. tact with air at all times. It reacts violently with most free Silane is generally noncorrosive halogens or heavy metal hydrides. When heated to 572°F (300°C), toward most construction silane begins to decompose into materials. Use diaphragm pack-CAir Products and Chemicals, Inc. 1977



#### II. Air Products and Chemicals, Inc. (Concluded)



# **SPECIALTY GASES**

SILANE Nitride Grade

	APCI Specification	"SEMI" Specification
Hydrogen	< 500 ppm	<u>≤</u> 500 ppm
0xygen	< 10 ppm	≤ 10 ppm
Argon - Rare	<b>&lt;</b> 40 ppm	<b>≤</b> 40 ppm
Nitrogen	< 40 ppm	Not Specified
Chlorides	< 10 ppm	<u>&lt;</u> 10 ppm
THC	< 10 ppm	<u>&lt;</u> 10 ppm
c0/c0 <sub>2</sub>	< 5 ppm	<u>&lt;</u> 10 ppm
Water	≤ 1 ppm	<u>≤</u> 3 ppm
Resistivity	> 100 ohm-cm	> 50 onm-cm

Gaseous Chemicals • Fluorine Compounds • Chemical Intermediates • Rare Gases • Custom Blends: • Calibration Gases • Multi-Component Gas Mixtures • Electronic Grade: Gases & Mixtures • Emission Control Gases • Sterilizing Mixtures • Moisture Mixtures • Special Gas Mixtures • Regulators • Flow Meters • Blenders • Manifolds • Manual Flow Control Valves

#### III. Ideal Gas Products, Inc.

# **Pure Electronic Gases**

Thousand Ohm Plus Silane (T.O.P.S.<sup>e</sup> Grade) is an exclusive new product, manufactured by Certified Gas and Controls, Inc.; sold and distributed by Ideal Gas Products, Inc. This product was made possible by the successful development of a totally new concept in silane purification.

In manufacturing silicon devices in clean systems, T.O.P.S\*Silane will increase yields, improve carrier mobility, lifetime, and remove thermal effects due to impurity carrier thermal activation. Remarkable gains in yield (up to 400%) have been obtained in production usage where the only parameter changed was from the use of "relatively impure" standard epi or electronic grade silane to T.O.P.S\*Silane.

Maintaining the extraordinarily high quality of T.O.P.S.\* Silane is our primary concern, and because of this, each cylinder is analyzed. Spreading conductance measurements are made on every lot of T.O.P.S.\*Silane to verify its exceptional resistivity. A bulk sample of silicon with a resistivity measured at 1750 ohm cm by a 4-point measurement is used for high end calibration. The raw resistance measured with this calibration sample is near to 1 megohm, with conductance G equal to 0.9 to 1.0 micromhos with the probe head used in our measurements. Only epi deposited from T.O.P.S.\* Silane in a clean system and which exhibits a raw conductance less than 1.2 micromhos is considered acceptable.

In addition, dC/dV plotting is made to measure carrier concentration. With observed carrier concentrations below 3 x 10<sup>12</sup> per cubic centimeter as measured by dC/dV plotting, and with 5 x 10<sup>22</sup> silicon atoms per cubic centimeter, the net NA-ND of less than 60 carrier contributing atoms per billion silicon atoms indicates the order of total impurities. Since other silanes are more strongly N type, this is an indication that the purification of T.O.P.S.\* is

IDEAL GAS PRODUCTS. INC. P.O. Box 709 Edison, New Jersey 08817 effective in reducing the level of phosphine (which is usually present at the low part per billion level) to the low part per trillion range. Since heavier elements would be more effectively removed than phosphorus by the purification processes employed, it is obvious that other heavy elements are removed to an even greater degree than phosphorous. Detection by any method other than electrical measurements on a single crystal structure deposited from this silane is impractical. A long list\_of elements at non-detectable levels would seem to be meaningless when the purity indicated by the carrier concentration is considered.

Concentration of other typical gaseous impurities is also closely monitored on each individual cylinder as shown below. Particular attention is given to cylinder preparation for T.O.P.S.\* Silane and for mixtures of T.O.P.S.\*with various carrier gases such as helium, hydrogen, nitrogen or argon, all of which are UHP grade gases.

#### **Purity Specifications:**

 Resistivity:
 1,000 ohms/cm minimum undoped epitaxial silicon deposited in a clean system.

 Chlorosilane:
 Non-detectable by sparging 10 liters of silane through 125 ml of deionized water (conductance <0.5 micromhos) without measurable increase in conductance. (This test method will also detect any impurity ionizable at infinite dilution.)</td>

 Hydrogen:
 100 ppm maximum

Nitrogen:	10 ppm maximum

Total Hydrocarbons as Methane: 2 ppm maximum Moisture: 2 ppm maximum III. Ideal Gas Products, Inc. (Concluded)

# Ideal Gas Products, Inc.

### **Pure Electronic Gases**

Purity	Molecular Weight	Specific Volume	Cylinder Valve Outlet	Cylinder Size	Contents	Price	Recommended Regulators
AMMONIA. Electr●nic. 99.995 % H₂O < 10 ppm	17.031	22.5 cu. ft./lb.	CGA 660	57 16	55 lbs. 16 lbs.	\$300.00 75.00	1500 Series
ARSINE, Electronic, 99.998%	77.946	5.0 cu. ft./lb.	CGA 350	7 7	5 lbs. 1 lb.	\$750.00 175.00	1500 Series
CHLORINE. Electronic, 99.98%	70.906	5.4 cu. ft/lb.	CGA 660	16 7 3	40 lbs. 15 lbs. 6 lbs.	\$300.00 170.00 100.00	1500 Series
DICHLOROSILANE Resistivity Capability: ≥ 50 ohms/cm. N type	100.99	3.83 cu. ft./ib.	CGA 330	44	50 lbs.	\$1500.00	1500 Series
<b>GERMANE,</b> 99.9%	76.62	5.1 cu. ft./lb.	CGA 350	7	100 g.	On Requ <b>e</b> st	1500 Series or 1900 Series
HYDROGEN CHLORIDE, Electronic, 99.995%	36.461	10.9 cu. ft./lb.	CGA 330	44 7	55 lbs. 8 lbs.	\$255.00 6€.00	1500 Series or 1900 Series
HYDROGEN SELENIDE, Electronic, 99.95 / 2	80.976	4.8 cu. ft./lb.	CGA 350	3	1 lb.	\$450.00	1500 Series or 1900 Series
HYDROGEN SULFIDE, Electronic, 99.99%	34.08	11.2 cu. ft./lb.	CGA 330	16	20 lbs.	\$275.00	1500 Series
NITROUS OXIDE, Electronic. 99.995	44.01	8 7 cu. ft./lb.	CGA 326	44 16	60 lbs. 20 lbs.	\$660.00 280.00	1400 Series or 1600 Series
PHOSPHINE, Electronic, 99.998° o	34.00	11.4 cu. ft./lb.	CGA 350	16 3	5 lbs. 1 lb.	\$650.00 175.00	1500 Series or 1900 Series
SILANE, T.O.P.S. * Resistivity ≥ 1.000 ohms/em CH <sub>4</sub> < 2ppm Uncompensated	32.12	12.1 cu. ft./lb. See pa	CGA 350 age 45 for s	44 44 44 7 pecificatic	10.000 g. 5.000 g. 1.000 g. 100 g. ms.	\$6.080.00 3.100.00 690.00 150.00	1500 Series or 1900 Series
SILANE, Electronic Resistivity ≥100 ohms/cm/ Uncompensated	32.12	12.1 cu. ft./ib.	CGA 350	44 44 7	5.000 g. 1.000 g. 10∎ g.	\$1700.00 400.00 85.00	1500 Series or 1900 Series

Quantity & scounds Avan die



#### IV. Linde Division, Union Carbide Corporation



FEATURES

- Resistivity greater than 100 ohm cm
- Lowest epitaxial temperature
- No corrosive by-products
- Maximum conversion efficiency to silicon
- Useable with sapphire substrates
- Accurate gas feed

Union Carbide Silane is widely accepted for epitaxial deposition of single crystal films and for polycrystalline silicon. The silicon content of silane is greater than that of any of the chlorosilanes. Its principal high temperature reaction is one of simple pyrolysis.

SiH<sub>4</sub> -----> Si + 2H<sub>2</sub>

There are no corrosive by-products from the pyrolysis and none of the reverse reactions common to the chlorosilanes are present.

Deposition temperatures, of Silane, as low as 800 °C in helium with no loss of crystallinity are possible. Low growth temperatures obtainable with silane tend to minimize impurity diffusion effects which become appreciable above 1000 °C.

Growth rates observed with silane are determined by the individual process and reactor geometry. Typically, rates between 0.2 microns per minute and 0.5 microns per minute are used for silicon epitaxy on a silicon substrate and up to 8.0 microns per minute are used for silicon epitaxy on sapphire substrates.

Silane usage is not limited to epitaxy. Low temperature chemical vapor deposition of silicon dioxide films by controlled oxidation of silane are finding increasing usage.

 $SiH_4 + O_2 \longrightarrow SiO_2 + 2H_2$ 

Some of the uses of silicon dioxide films are in integrated circuit manufacturing for device passivation, as dielectrics in multilevel metalized circuits and in MOS technology.

Chemical vapor deposition of silicon nitride films formed by the controlled reaction of silane and ammonia are also being increasingly used.

 $3SiH_4 + 4NH_3 \longrightarrow Si_3N_4 + 12H_2$ 

Typical applications of silicon nitride films are insulation, passivation and sealing of devices and integrated circuits.

Silane is shipped as a gas in high pressure cylinders. It is also available in gas mixtures with hydrogen, helium, argon or nitrogen. Since it is supplied in gaseous form, it may be very precisely metered into reactors, eliminating the need for bubblers and their inherent inaccuracies.

Established conditions for chemical vapor deposition reactions are easily reproduced.

PHYSICAL PROPERTIES

Odor choking
Color
Molecular Weight 32.1
Specific Volume @ 70°F, 1 atm 12.0 ft <sup>3</sup> /lb
Boiling Point @ 1 atm
Freezing Point @ 1 atm301°F (-185°C)
Density, Liquid @ - 301 F
Density, Gas @ 0°C, 1 atm 1.44 g/l
Viscosity, Gas @ 15°C 112.4 micropoise
Critical Temperature
Critical Pressure
Flammability Limits in Air Spontaneously flammable
Heat of Formation, Gas @ 25°C 7.3 kcal/mole
Latent Heat of Vaporization @ b.p 2.96 kcal/mole
Heat Capacity, Gas @ 25°C,
1 atm. Cp

#### PRODUCT SAFETY

Specialty Gases include products with properties that can cause serious accidents, injuries, and even death if proper precautions and safety practices are not followed. Therefore, be certain to use all applicable safety precautions described in *Specialty Gases Safety Precautions and Emergency Procedures*, F-12-237, during storage, handling and use of these gases. F-12-237 is available on request from Union Carbide or from your Union Carbide Distributor.

This information is not to be taken as a warranty or representation for which we assume legal responsibility nor as permission or recommendation to practice any patented invention without a license. It is offered solely for your consideration, investigation and verification

### SERI 🏶

#### IV. Linde Division (Continued)

#### GAS REGULATION

Union Carbide Silane Regulators Models SG-3862 and SG-3865 are especially designed to handle silane and silane gas mixtures. Seat leakage caused by contamination from the reaction of silane with air is virtually eliminated. The valve stem (poppet) is attached to the diaphragm, forming a single unit. If a seat leak occurs, the increasing delivery pressure will cause the stem to be pulled tighter and tighter against the seat until it seals off. This feature also permits the regulator to be used at very low inlet pressures.

Models SG-3862 and SG-3865 regulators have a stainless steel body, diaphragm, inlet filter and gauges, and outlet shut-off valve. Regulator and valve seat both are Kel-F. A factory-installed purge assembly and a diffusion-resistant diaphragm seal shutoff valve on the outlet are standard.

Helium mass spectrometer leak detector tests of representative Models SG-3862 and SG-3865 regulators show an inboard leakage rate of less than 1 x  $10^{-6}$  cc/second. The regulators are available with either a 0- to 15-psig or an 0- to 75-psig delivery pressure range as shown in the table below.

Inlet Pressure Gauge psig	Delivery Pressure Range psig	Part No.	
0 - 3000	0 – 15	SG 3862-350	
0 - 3000	0 – 75	SG 3865-350	

### TOXICITY

The toxicity of silane is unknown. However, because of its combustion on contact with air yielding no known toxic by-products, the major hazard associated with silane is primarily from its spontaneous flammability with air.

Initially, the stigma of being pyrophoric caused a slow acceptance by industry of silane. However, it is now recognized as being no more hazardous if not even safer to handle than hydrogen. When a leak develops, it immediately burns with no release of known toxic fumes or buildup of an explosive atmosphere. The flame on burning is a relatively "cool" flame with no danger of melting metal tubing or other assorted apparatus resulting in some type of catastrophe. In many cases of small leaks, the resulting silica formed at the point of leakage seals itself. And in all cases, the fire is stopped by simply shutting off the cylinder valve to isolate the gas source.

#### MATERIALS OF CONSTRUCTION

Silane is non-corrosive to most metals. Piping and tubing can be of iron, brass,steel, stainless, or aluminum. However, Type 316 stainless steel is recommended in plumbing of reactors and gas delivery systems. Stainless steel regulators should be used for all high purity applications with silane. All piping and tubing should be designed to withstand the pressures to be encountered.

#### IV. Linde Division (Continued)

#### HANDLING AND STORAGE

Silane and silane mixtures can be handled safely with the proper precautions to *avoid contact with air at all times*. Almost all recommendations are directed at not violating this one rule. Specific precautions that should be observed in handling silane are as follows:

- Before using silane, read all equipment instructions, cylinder labels, data sheets, and other associated information pertaining to silane and its use.
- Handle silane in a well-ventilated area while avoiding the presence of combustible materials,
- 3. Store silane at positive pressures.
- 4. Do not condense silane (-110°C or less). Condensation of silane runs the risk of leaks developing with subsequent suck back of air into the system forming explosive mixtures.
- 5. Do not use silane in conjunction with heavy metal halides or free halogens which react violently. Care should be taken that all components of any silane handling system are purged of free halogens that might exist from degreasing agents or chlorinated hydrocarbons.
- 6. All systems to handle silane should be designed with these facts in mind:
  - a. Prevention of leakage, both in and out, under vacuum and pressure.
  - b. Minimum necessary internal volume
  - c. Elimination of dead spaces.
  - d. Isolation of system components in case of a leak, rupture, or other failure.
  - e. Ability to easily evacuate and purge the system and components with inert gas.
  - f. Silane should never be purged through a vacuum pump.
  - g. All fittings preferably should be of the welded type or Swagelok style to minimize the likelihood of leaks
  - h. Use diaphragm packless valves with resilient seats such as *Teflon*,
  - i. Remove backplates from gauges and rotometers where gases may collect on leakage.
  - j. Use metal diaphragm regulators to minimize air diffusion leakage.
- All systems should be evacuated and thoroughly pressure checked for leaks at pressures two to three times the anticipated working pressure. In addition, a regular leak test procedure and testing schedule should be instituted and followed as part of normal preventive maintenance.
- 8. Ground all equipment and lines using silane.

- An alternate vacuum and inert gas purge of the system should be used to purge all air out of the system after it has been leak checked.
- When pressurizing the equipment with silane or a silane mixture, open the cylinder valve slowly. All other equipment adjustments of regulators, needle valves, etc., should also be made slowly.
- 11. Before disconnecting any system that has had silane in it, thoroughly purge the system of silane with an inert gas. Any portion of a system that is dead ended or allows "pocketing" of silane should be treated by considerable purging in the order of ten times the trapped volume.
- 12. Venting of silane or silane mixtures should be through small diameter pipe or tubing ending under a shallow water seal to prevent back diffusion of air. Venting should be to an area designed for silane disposal, preferably by burning. Concentrations even in the low percentage range are dangerous and should not be exposed directly to air except for disposal.
- Do not store cylinders with oxidizers such as oxygen, chlorine, or flammable materials.
- In addition, observe the following good cylinder practices in the handling and storage of silane:
  - a. Removable cylinder caps should be kept on cylinders at all times until they are secured against a wall, bench, or placed in a cylinder stand and are ready to use.
  - b. Never drop cylinders or permit them to strike each other violently.
  - c. Do not lift cylinders by the cap.
  - Avoid dragging, rolling, or sliding cylinders even for a short distance. They should be moved with a suitable hand truck
  - e. No part of any cylinder should be subjected to a temperature above 125°F. A fiame should never be permitted to come in contact with any part of a compressed gas cylinder.
  - f. Cylinders should never be subjected to artificially created low temperatures.
  - g. Keep the cylinder valve closed at all times, except when the cylinder is in active use.
  - h. Never tamper with cylinder valves or attempt to repair or alter cylinders or valves.
  - Never use compressed gases where the cylinder is apt to be contaminated by the feedback of process materials, unless protected by suitable traps or check values.
  - j. Notify the owner of the cylinder if any condition has occurred which might permit any foreign substance to enter the valve or cylinder, giving details and cylinder serial number.
  - k. Cylinders should be stored in an assigned area that is dry, cool, well ventilated, and fire resistant.

#### IV. Linde Division (Concluded)

#### HAND LING AND STORAGE (Continued)

Storage should comply with all local, state, and municipal regulations.

- Cylinders stored in the open should be protected from extremes in weather and not exposed to continuous dampness or other corrosive conditions.
- m. When returning empty cylinders, close the valve before shipment and leave some positive pressure in the cylinder. Replace all gas tight valve outlet caps and valve protective caps. Do not repaint, remove, or deface any cylinder markings, labels, decals, tags, and stencil markings used by the supplier for identification. Mark the contents label EMPTY.

#### DISPOSAL

Silane, silane mixtures, and silane purge or vent gases can readily be treated to destroy the silane by several means as follows:

- 1. Burning the silane by slowly bleeding silane containing gases into a continuously burning pilot flame.
- 2. By venting the silane containing gases slowly to the air through a water seal and burning by self ignition of the silane in an isolated area away from personnel.
- 3. Scrubbing the silane through a caustic bed or caustic solution (10% sodium hydroxide).
- 4. By reaction with aqueous mercuric chloride.

AVAILABILITY AND SHIPPING DATA

Pure silane is available in steel high-pressure cylinders of DOT 3AA2015 or 3AA2400 specification as follows:

Cylinder Size	Grams Silane	Cylinder Pressure (psig)	Cylinder Dimensions	Shipping Weight
т	16000	1650	9 x 55″	180 lbs.
Т	10000	1250	9 x 55″	167 lbs.
т	5000	730	9 x 55″	156 lbs.
к	12000	1315	9 x 52″	161 lbs.
к	5000	780	9 x 52″	146 lbs.
к	1000	235	9 x 52''	137 lbs.
G	600	625	6 x 20''	32 lbs.
G	200	200	6 x 20″	31 lbs.

The cylinder valve is of a diaphragm, packless forged brass construction with safety devices. The valve outlet is of 350 CGA (Compressed Gas Association) design which has .825" –14 NGO left hand external threads and is bored to accept

a .5725" round nose nipple



Silane is classified by the D.O.T. (Department of Transportation) as a flammable gas and carries a D.O.T. FLAM-MABLE GAS shipping label. All silane cylinders are shipped with a gas tight cap on the valve outlet.

Silane is also available in gas mixture form with various background gases such as hydrogen, argon, nitrogen, and helium in varying concentrations. Additional information is available on request.



UNION CARBIDE CORPORATION • LINDE DIVISION P.O. Box 444, 100 Davidson Avenue, Somerset, N.J. 08873 • Telephone (201) 356-8000 TWX 710-997-9550 • TLX 833-199

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Printed in U.S.A

# SER

#### V. Liquid Carbonic, Subsid. of Houston Natural Gas Corporation



**LIQUID CARBONIC** Natural Gas Corporation

### SPECIALTY GAS TECHNICAL SALES BULLETIN

#### SILANE SPECIFICATION #SG-3

Product	Silane
Physical State	Gas, SiH <sub>4</sub>
Guaranteed Minimum Purity	99.370 %
Typical Purity	99.99%
Film Resistivity <sup>(1)</sup>	
Epitaxial Grade Polysilicon or Oxide Grade Silicon Nitride Grade Charge Couple Device Grade HRS Grade	> 100 ohm-cm (N-type) > 50 ohm-cm " > 50 ohm-cm " > 200 ohm-cm " > 400 ohm-cm "
Typical Maximum Impurities (Gases)	Net Contents Silane Available in Cylinders
Oxygen - ND Total Hydrocarbons - 10 ppm	1,000 Grams (9" X 52") 3.000 Grams (9" X 52")

ΡF Water - ND Carbon Monoxide/Carbon Dioxide - 10 ppm Hydrogen - 500 ppm Chlorosilanes (as choloride ion) - 10 ppm Nitrogen - Less than 100 ppm Trace Metals (3)

Net Contents Silane					
Available i	n Cyl	ind	lers	(2)	
1 000 0	(0)		6.011)		
1,000 Gram	ns (9	х	52)		
3,000 Gram	n <b>s (9"</b>	Х	52")	)	
5,000 Gram	n <b>s (9"</b>	Х	52")		
14,000 Gram	ns (9"	Х	55")	)	

(1) Determined by four point probe method.

(2)Other quantities and cylinder sizes available on request.

 $\ensuremath{^{(3)}}\xspace_{To}$  be determined between supplier and customer.

Recommendation for Valve and Regulator - Valve CGA 350 Stainless Steel. Regulator - Liquid Carbonic Model #800S, 700S, Safety-T-Purge Module TDR#440 or TDR#450.

Revised #6 - Feb. 1983

LCCO Form 2930C

TB-186

VI. Matheson Division, Searle Medical Products USA Inc.

# Matheson TECH/Brief

Disilane — Si<sub>2</sub>H<sub>6</sub>

**Background** — Disilane, the dimer of SiH<sub>4</sub>, has recently received considerable attention, especially from research workers in amorphous silicon photovoltaics.<sup>1</sup>

High deposition rates at low substrate temperatures make this new material a strong candidate for further studies in plasma and low pressure chemical vapor deposition systems as a source of high quality amorphous or polycrystalline silicon.

Matheson is pleased to offer disilane from stock. Presently, 25 gram stainless steel cylinders are stocked in our Gloucester, Mass, branch. Other quantities are available upon request. The DOT-3E1800 container and packless valve are sold outright, with a credit upon return.

#### Gas Properties — Typical Purity

Si₂H <sub>6</sub>	99 + %
H <sub>2</sub>	0.15%
Si,H,Cl,	less than 100 ppm
SiH₄	0.5%

Disilane shows a slight tendency to decompose at room temperature with the production of hydrogen and silane. The Matheson's material is purified just prior to shipment: actual Si, H<sub>0</sub> content is at least 25 grams at time of shipment. Purity is a function of time and temperature.

Disilane is a flammable, pyrophoric gas, shipped as a liquid under its own vapor pressure of 32 psig at 70°F, 21.1°C. Calculated (approximate) vapor pressures are as follows:

Temp. C	Pressure, PSIA
0	20.8
10	34.3
20	45.5
25	53.2
30	60.9
40	78.3

Equipment — Maintenance of safety and purity is important. Because disilane is a liquid in the cylinder, it should not be placed horizontally during use. Matheson offers an appropriate cylinder stand, regulator and purge combination which minimizes interior volume and package weight while it maximizessafety, purity and ease of use.

Matheson's 3455 regulator and 1423-SP cross purge assembly and Model 505 cylinder stand provide the user with a proven design, maintaining high purity with minimal loss of gas during purging.

- Scott, B.A. et al, Glow Discharge Preparation of Amorphous Hydrogenated Silicon from Higher Silanes. App. Phys. Letter 37, 1980 — pg. 725-727.
- Wiberg, E. & Amberger, E. Hydrides of the Elements of Main Groups I-IV; Elsevier Publishing Co., 1971.
- Harper, L.R., Yolles, & Miller, H.C. Decomposition of Disilane, Separation of Silane/Disilane Mixtures by Gas, Phase Chromotography.J.Inorg. Nucl. Chem., 1961, Vol. 21, pg. 294-296.
- 4) Wiberg & Amberger, Ref. 2

Twinsburg, Ohio 44087 P.O. Box 358 East Rutherford, N.J. 07073 P.O. Bine 85 CANADA Gonzales, Louisiana 70737 1805 Southland Drive Phone (504) 644 5303 EUROPE 2153 GB Nieuw Vennep. The Netherlands P 12 Box 85 932 Paterson Plank Road Phone 12011 933 2400 Telex 424546 MATHSN Whitby: Ontario L1N 5R9 P.O. Box 89 530 Watson Street East Phone (416) 663 3397 2431 Oevel, Belgium Nijverheirteariaat 4 Phone 10141 580955 Telex 32419 1650 Enterprise Park way Phone - (216) 425 4406 Hoverstraat 40 Plome - 02526 73842 Toti x - 71267 Baton Rouge, Louisiana Direct line to Gonzales 343 0364 Gloucester, Massachusetts 01930 P.O. Box 1147 61 Grove Street Phone (617) 283 2200 New York, New York Direct line to East Rul 947 6397 6056 Heusenstamm, West Germany Niedertreider Viet 30 Phrane – 05:154:2060 Tetrix – 4:10140 Edmonton, Alberta T58 4K6 P.O. Box 6240 Station "C" 12143 68th Street Phone (403) 471 4036 Trites 037 2113 La Porte, Texas 77571 P.O. Bux 908 Morrow, Georgia 30260 P.O. Box 136 6874 South Main Street Prinne: (404) 961 7891 P O. Box 90n 1920 West Fairmont Parkway Phone - (713) 471 2544 Joliet, Illinois 60434 P.O. Box 96 Manhattan Road & Richards Stree Phone - (815) 727 4848 Ottawa, Ontario K1G 0N1 1665 Rosett Road – Unit 9 Phone – (613) 521 6504 Cucamonga, California: 91730 8800 Dina Avenue Phone: (714) 987-4611 Igeport, N.J. 08014 Box 38 Heron Drive ne (609) 467 2770 Chicago, Illinois Direct line to Joket 242 1321 Calgary, Alberta T2A634 Boy 6, 3110 14th Aprilue, N.E. Phone : 14030248 1668 Matheson Newark, California 94560 6775 Central Avenue Phone 14151 793 2559 Baltimore, Maryland 21227 6655 Amberton Drive Unit 0 Phone 13011 796 0517 Dayton, Ohio 45424 eblog Larie 1513) 236 3024

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#### VI. Matheson Division (Concluded)

# Matheson TECI-I/Brief

TB-191

# MATHESON PURITY SILANE 1000 ohm-cm

Matheson has responded to revolutionary changes in purity requirements for semiconductor processing with a new grade of silane. This new material is purer by orders of magnitude than normal, commercially available silane.

The new Matheson Purity Silane costs more, but is clearly economical when yield improvements are attributed to its use. Maximum cost-effectiveness is noted in critical epitaxial and poly-silicon depositions. Nitride and critical oxide depositions also benefit from reduced defect densities caused by particulates and volatile impurities.

Purification to remove active dopants has resulted in silane with a resistivity of 1000 ohm-cm. This effectively reduces most metallic and reactive impurities to limits imposed by cylinder preparation. Analysis of process stream silane for these impurities before compression into cylinders would be of no value. Matheson's proprietary cylinder treatment techniques assure that the container contribution is minimal.

The true test of Matheson Purity Silane lies in your end-use results . . . yield increases, better process control, low leakage, higher lifetime, fewer stacking faults are just some of the potential gains that can be realized with this material.

Matheson Purity Silane is available in cylinders containing 12,000, 5,000 and 1,200 grams net contents.

East Rutherford, N.J. 07073 PO Box85	Twinsburg, Ohio 44087 P O Box 358	Gonzales, Louisiana 70737 1805Southland Drive	CANADA	EUROPE	2153GB Nieuw Vennep, The Netherlands
932 Paterson Plank Road	1650 Enterprise Parkway	Phone (504) 644-5303	Whitby, Ontario £1N 5R9	B 2431 Oevet, Belgium	Haverstraat 40
Phone (201)9332400	Phone (216) 425 4406		P.O Bu× 89	Neverbeidstraat238	Phone 2526 73842
Telex 424546 MATHSN		Baton Rouge, Louisiana	530Watson StreetEast	Phone (014) 580 955	Telex 71267
	Gloucester, Massachusetts 01930	Direct line to Gonzales	Phone: (416) 668-3397	Telex 32419	
New York, New York	P.O Box 1147	3430364	Cable: TWX6103842752		
Directline to East Rutherford	61GroveStreet			6056 Heusenttamm, West Germany	
9476397	Phone (617) 283 7700	La Porte, Texas 77571	Edmonton, Alberta TSB4K6	Nederroeleowin 30	
	Cable TWX 7103471310	PO. Box 908	PO Bex 6240 Station "C"	Phone 06104 2060	
Morrow, Georgia 30260		1920 West Fairmont Parkway	12143 68th Street	Telex 4 10141	
PO Box 136	Joliet, Illinois 60434	Phone (713)4712544	Phone (403) 471 4036		
6874 SouthMain Street	PO Box 96	Cable TWX 910-880-4064	Cable TWX 610 831 2126		
Phone (404)961-7891	Manhattan Road & Richards Street				
	Phone, (815) 727-4848	Cucarnonge, California 91730	Ottawa Ontario K1G DN1		
Bridgeport, N.J. 08014	Cable TWX 910633 1943	8800Utica Avenue	1665 Russell Road - Unit 5		
PO Box38		Phone: (714) 987 4611	Phone (613)521-6504		
6D3HeronDrive	Chicago, Illinois	Cable TWX 910 581 3814			
Phone (609) 4672778	Direct lineto Joliet 242 1321		Calgary, Alberta T2A6,4		
		Newark, California 94560	Bay 6, 3110 14th Avenue, N.E.		
Dayton, Ohio 45424	Baltimore, Maryland 21227	6775 Central Avenue	Phone (403) 248-1668		
8135 Uehling Lane	6655 Amberton Drive Unit0	Phone (4151 793-2559			
Phone (51312363021	Phone (3011 796 0517	Cable TWX 9103816051			

### VII. Scientific Gas Products, Inc.

	GAS SPECIFICATIONS AND PRICES			RECOMMENDED CONTROLS					
SILANE SIH4	Cylinder Size	Contents (grams)	Gross Wt. (ibs.)	Price	Cylinder charge	Туре	Model	Price	See Page
V.L.S.I. Grade Specification: 99,99% Min.* Minimum Resistivity	1С-5К 1С-3К	5000 3000	136 131	\$8500.00 4350.00	See Page 4		Controis for S	Silane	
1500 ohm-cm Maximum Impurities: Nitrogen 10 ppm Oxygen 5 ppm THC as	,					Single Stage Diffusion Resistant Regulater	R51 <b>B</b> -350	\$135.00	85
Methane 5 ppm Helium 10 ppm Hydrogen 4500 ppm Water Vapor 1 ppm Chloresilanes						Two Stage Diffusion Resistant Regulator	R58A-350	205.00	86
10 ppm Rare Gases 10 ppm *excludes Hydrogen content						Stainless Steel Single Stage Regulator	R35E-350	290.00	87
Nitride Grade Specification: 99.96% Min, Minimum Resistivity 100.0hm-cm Maximum Impurities Oxygen 10.ppm THC as	1C-5K 1D 1C 15	5000 3000 1200 100	136 131 125 30	\$2750.00 1600.00 780.00 115.00	See Page 4				
Water Vapor 3 ppm Hydrogen 500 ppm Chtorosilanes 10 ppm Rare 40 ppm	QL	IANTITY DIS	SCOUNTS	VAILABLE					
Epitaxial Grade Specification: 99.8% Minimum Resistivity 100.0hm-cm	1C-5K 1C-3K 1C-1K 15	5000 3000 1200 100	136 131 125 30	\$1800.00 1110.00 460.00 95.00	See Page 4				
Maximum impurities Nitrogen 40 ppm Oxygen 10 ppm THC as Methane 40 ppm Hydregen 1000 ppm Water Vapor 3 ppm Chlerestanes 1000 ppm Rare 40 ppm									
Semiconductor Grade Specification: 99.7% Min Minimum Resistivity 50.0hm-cm Maximum Impurities;	1C-5K 1C-3K 1C-1K 15	5000 3000 1200 100	136 131 125 30	\$1600.00 1080.00 504,00 90.00	See Page 4				
Ni tragen 20 ppm Oxygen 10 ppm THC as Methane 50 ppm Water Vapor 3 ppm Hydrogen 2000 ppm Chlorosilanes 1000 ppm									
Specific Volume 1	GAS AND CYLINDER DESCRIPTIVE DATA								
Scientific Gas Products Inc. 10-3K-130 psig 2330 Hamilton Boulevard 15120 psig						73			

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# SERI 🐞

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#### VIII. Synthatron Corporation

SYNTHATRON CORPORATION 50 INTERVALE ROAD PARSIPPANY, NEW JERSEY 07054

March 8, 1983

TEL. 201.335.5000 TLX 136454

Mr. J. H. Lorenz

Dear Mr. Lorenz:

I am writing you this letter in response to the survey form on Silane and Disilane which you forwarded to us on February 25.

1. Synthatron manufactures and sells both mono-Silane and Disilane. As you might understand, we consider our manufacturing and purification processes proprietary, as do most people in the specialty gas business.

2. We make Silane available at various purity levels. The best Silane we sell currently can be characterized by the following typical analyses:

Impunition	Typical
Impullities	concentration
Nitrogen	<b>&lt;</b> 100 PPM
Oxygen	< 1 PPM
Water	<b>2</b> PPM
Hydrogen	< 50 PPM
Carbon Monoxide + Carbon	< 10 PPM
Dioxide + Methane	
Methane	🗲 5 РРМ
Chlorosilane	🗸 5 РРМ
Argon	S PPM
Silane	Balance

The impurity profile of a typical lot of Synthatron Disilane would be as follows:

Impurities	
H <sub>2</sub>	0.5 - 1.6%
NŽ	< 50 PPM
02	<b>&lt;</b> 50
Ar	<b>&lt;</b> 50
CÔ2	< 20
co <sup>-</sup>	<b>&lt;</b> 50
CH <sub>4</sub>	<b>&lt;</b> 10
$C_2 H_6$	<11
$C_2H_4$	<b>&lt;</b> 1
C <sub>3</sub> H <sub>8</sub>	< 1
Chlorides	. 5%
Some	99.0% pure

#### VIII. Synthatron Corporation (Continued)

Mr. J. H. Lorenz Page 2 March 8, 1983

3. Most of our impurity analyses are performed by gas chromatography and a complete analysis for each of the listed impurities is available on an individual cylinder basis for \$125.00.

4. Synthatron holds a voting membership on all of the relevant SEMI committees. We have approved and voted for the SEMI Silane standards and have contributed our in-put to their development. Naturally, we are prepared to analyze our material to insure its compliance with these standards.

5. Because of the hazardous nature of Silane, we do our best to discourage our customers' running their own purification processes on the material. If, however, a specific impurity is of particular concern to a customer, we can give him advice concerning purification for that specific impurity on an ad hoc basis.

6. I have enclosed data sheets on the Silane currently available from Synthatron. Together with the typical analysis listed above, that should give you a comprehensive view of the materials we make available. Pricing on this material is contengent on total volume and quantity per package. In general terms, it can be said that the price will range between \$.19 per gram and \$.55 per gram. The cylinder sizes available from our company expressed in their volumetric capacities, expressed in liters of water, are as follows: 0.44 liters (lecture bottle), 3.7 liters (No. 3), 6.9 liters (No. 7), 16.7 liters (No. 16), 43.8 liters (No. 44), and 49.0 liters (No. 49).

Should you have any further questions concerning Synthatron's Silane or Disilane, please call me at your convenience.

Yours truly,

SYNTHATRON CORPORATION

Michael Hayes

Michael Hayes / National Sales Manager

MH/ss

Encl.



### VIII. Synthatron Corporation (Concluded)

Synthatron	SPE	SILAI	NE
SYNTHAIRON CORPORAT	<b>ION</b> 50 IN	TERVALE ROAD, PAR	SIPPANY, N.J. 07054
201-335-5000 TEX 136454		SEMI-GR	ADE
	(ТМ	PURITIES	ін ррм)
IMPURITY	POLYSILICON	EPITAXIAL	NITRIDE
Oxygen (O <sub>2</sub> )	10	10	10
Water (H <sub>2</sub> O)	3	3	3
Hydrogen (H <sub>2</sub> )	10,000	10,000	500
Carbon Dioxide and Carbon Monoxide (CO <sub>2</sub> + CO)	10	10	10
Total Hydrocarbons	40	40	10
*Chlorosilane	1,000	1,000	10
Rare Gases	40	40	40
Nitrogen	-	40	-
**Resistivity	50 ohm-cm	100 ohm-cm 5	50 ohm-cm

\* Ionizable chlorides including HCL reported as Cl.

\*\* Greater than, n-type.

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1617 Cole Boulevard Golden Colorado 80401		14.
15 Supplementary Notes		
Technical Moniton, Amin Mikhail		
16. Abstract (Limit: 200 words) Silane and disi the semiconductor market. Published for monosilane and higher silanes ar reviewed. Data from current silane silanes in Japan is given. Analytica mine group 3 or 5 elements in silane impurities. There is no simple one a user could easily operate. Typica given. Disilane is still in the deve available at very high prices. The JPL Flat Plate Solar Array project I purity silanes are now appearing on photovoltaic area.	ane are currently av or public informatio re discussed. Puri suppliers is tabulate al procedures are not e. All commercial sil step purification tec l and actual analyses elopment stage with c silane process develo by Union Carbide is s the market. These sh	vailable as prepared for on on preparative methods fication techniques are ed. A short review of the c now perfected to deter- anes contain certain chnique for silane which s of commercial silane are only small quantities oped in part under the DOE/ summarized. Higher hould be useful in the
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